

# Probing systems and accessories for bridge CMMs



# **Operating Instructions**



# **Read this first!**

- Please read these operating instructions before starting the coordinate measuring machine (CMM).
- For your own safety, please keep all relevant accompanying documents always ready at hand.

All rights pertaining to changes in the CMM and its options, the program packages and the pertaining documents reserved.

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#### Contact

Carl Zeiss Unternehmensbereich Industrielle Messtechnik GmbH D-73446 Oberkochen

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# Glossary

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# Preface

# Information about these operating instructions

These operating instructions describe the probing systems used on bridge CMMs. Please refer to the operating instructions to see which probing system is suitable for the respective CMM.

These operating instructions address operators and users of the coordinate measuring machine.

# Terminology

In this document, the terminology for coordinate measuring machines according to EN ISO 10360-1 is used.





# **Configuration of safety instructions**

Safety instructions indicate a personal health hazard. We distinguish three different levels: Danger, warning and caution. All three safety instructions are marked with the same warning symbol. The designation of the safety instruction is shown beside the symbol. The safety instructions used are described below.

# **Configuration of a safety instruction**

A safety instruction may have the following components:

- Warning symbol and designation of the safety instruction (signal word): Danger, warning or caution.
- Source and cause of the danger
- Consequences for the user due to non-observance of the safety instruction
- Required measures to be taken by the user to avoid possible consequences
- A measure may cause an intermediate result.
- At the end of all measures, a final result may be caused.

# Personal health hazard



#### DANGER

A »danger« indicates an imminent risk to life and limb. Non-observance of this safety instruction when the described risk occurs causes death or serious injuries. *Example*: Electric shock due to high electric voltage.



# 

A »warning« indicates a possible risk to life and limb. Non-observance of this safety instruction when the described risk occurs may cause death or serious injuries.

*Example*: Risk of severe crushing of the body caused by heavy loads.



# 

A »caution« indicates a personal health hazard.

Non-observance of this safety instruction when the described risk occurs may cause slight to moderate injuries.

*Example*: Risk of minor crushing of the limbs caused by small loads.

# **Risk of material damage**

If there is no personal health hazard, but the CMM or components may get damaged, this is pointed out by the following notice.





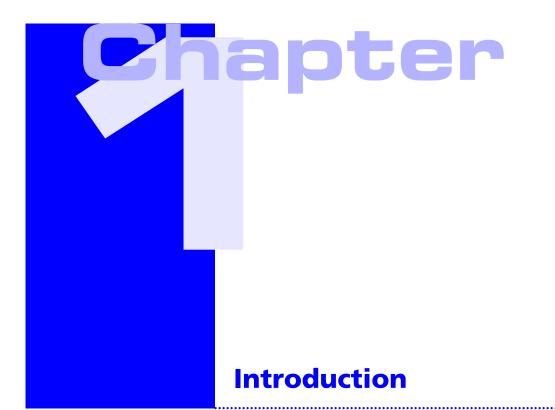
**This symbol refers to possible damage to the CMM.** Non-observance of this safety instruction when the event occurs may cause damage to the CMM or one of its components. *Example*: Collision of the ram with a workpiece.

# **Marking elements**

The texts may be displayed differently in this document. Examples and the meaning of the representation type are described below:

Example	Meaning
not	Words to be emphasized are represented in <i>ital-ics</i> .
	The italicized print is sometimes used to mark a subheading, e.g. <i>Type of measurement:</i>
Main switch	Any reference to operator's controls in the text is highlighted typographically.
Tolerance field	Designation of subdomains in software windows.
Cancel	Marking of buttons
RETURN	Keys of the keyboard are represented as small capitals.
"InstallShield Wiz- ard completed"	Software messages
$\textbf{File} \rightarrow \textbf{Open}$	Representation of menu items
Code	Source code
\Calypso\opt \om\protform	File and directories
CALYPSO	Product name
ZEISS	Company name
CAUTION! The measuring table must be clean.	Safety instruction embedded in the text.
[1]	Representation of position numbers in texts





This chapter informs you about the applications of the probing system.

# This chapter contains:

Intended use	1-2
Notes on the use	1-4

# **Intended use**

# **Probing system**

The probing system is a high-tech product which may be used only for its intended purpose.

**Probing** CMM probing systems are designed for determining the *coordinates* of a workpiece. This is usually achieved via probing, during which the workpiece is probed by a stylus tip. In some cases optical measuring methods are used. The probing system comprises several components, such as the probe carrier, probe and stylus system.

Linear scales The linear scales are integrated into the machine axes of the CMM and protected by covers. These covers must be attached when the CMM is in operation to prevent improper use.

# **Probes and probe carriers**

We can differentiate between two cases:

- Normally, the probe is attached to the ram by means of an adapter.
   In this case, the probe is also the probe carrier.
- On the other hand, there are probe carriers, which are not probes at the same time. In this case, a probe is fastened to a probe carrier. The probe carrier can be an articulating head, such as an RDS articulating head.

The stylus system, used for probing, is inserted on the probe. The probe and stylus system must be handled carefully.

#### Probe functions:

- Holding the stylus system.
- Exact positioning of the stylus system.
- Detecting the stylus system deflection and transmitting the signal to the computer.

The computer calculates the coordinates of the probed point.

# Stylus system

The stylus system consists of several components: Adapter plate, stylus and stylus system components. One or more styli can be mounted on a stylus system. The stylus tip is located at the end of the stylus.

#### Functions of the stylus system:

- The adapter plate holds and positions the stylus system exactly in the probe.
- Workpiece probing is carried out by the stylus tip.

# **Reasonably foreseeable misuse**

The probe, the probe carrier and the stylus system must not be used for purposes other than their proper use.

#### **Examples:**

- The probe must not be used as a support.
- The stylus system must not be used as a lever arm, e.g. to loosen a ring bolt.
- The stylus system must not be used as a hammer.

# Notes on the use

# Warranty, standards, safety

The probing system is part of the CMM, for which certain standards apply. Furthermore, to operate the CMM, the safety instructions must be observed. See operating instructions for the CMM.

# Operating instructions for the CMM

The operating instructions for the CMM include information on the following topics:

- Machine safety
- Standards, regulations and directives
- Warranty
- Safety

#### **Travel movements**

There is a risk of injuries during all movements of the CMM. The speed of the travel movements and the travel direction are irrelevant. Travel movements take place in the three CMM axes X, Y, Z and during rotation of the rotary table.

#### Work on the CMM



# A WARNING

# Risk of injury during high travel speed movements and rotation of the rotary table axis.

Crushing and cutting of parts of the body.

Risk to the eyes caused by the styli. Styli can hurt the eyes during travel movements if you approach your head close to the workpiece during probing.

- Make sure that no travel movements are possible when installing the probing system on the CMM.
- Switch the drives off before setting up the probing system on the CMM.
- Please read the notes in the operating instructions for the CMM.

Setup of the probing system includes:

- Mounting and dismounting of the probe carrier
- Mounting and dismounting of the probe
- Installing and removal of a stylus system.



# **Disposal**

# NOTICE

Some parts of the probing system contain electronic components and must not be disposed of with domestic waste. Make sure to dispose of the components in question in accordance with the WEEE directive 2002/96/EC or the respective country-specific legislation applicable within the 27 EU states.







# 

This chapter provides an overview of the available probing systems. Furthermore, you receive information on special features of the probing system, also in respect of the measuring run.

.....

# This chapter contains:

2 <b>-</b> 2
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# **Overview**

# **Probing systems - overview**

It is differentiated between trigger and measuring probing systems. For the measuring probing systems, a distinction is made between passive and active measuring. There are also optical probing systems:

Probing system		Triggering	Measuring		Optical	
			Passive	Active		
ST		×				
ST 3		×				
ST-ATAC	ST 3 with ATAC technology					
DT DynaTouch	Frequently only called DT.			×		
DTS			×			
XDT		×				
VAST XXT	Frequently only called XXT.		×			
VAST XT and VAST XT gold				×		
VAST XTR				×		
VAST and VAST gold				×		
HSS				×		
RDS with RST or RST-P	The RST-P is an en- hancement of the RST	×				
RDS with XDT		×				
RDS with VAST XXT			×			
RDS with TP6		×				
RDS with TP2		×				
RDS with TP20		×				
RDS with TP200		×				
RDS with SP25 or SP25M			×			
RDS with SP600			×			
RDS with ViScan					×	
RDS with DTS					×	

Probing system		Triggering	Measuring		Optical
			Passive	Active	
RDS with LineScan					×
Renishaw	Combination of ar- ticulating head with probe, e.g. MIH with TP6	×			

## NOTICE

Almost all probing systems are contact probing systems. Only RDS with ViScan, RDS with DTS and RDS with LineScan are optical probing systems.

# Probing system components and functions

# **Probing system components**

#### Probe and probe carrier at the same time

Probe	ST	<b>ST 3</b>	DT	XDT and VAST XXT	VAST XT	VAST	HSS
Adapter plate	×	×	×	×	×	×	×
Stylus / Stylus system	×	×	×	×	×	×	×

#### NOTICE

The version of the adapter plate depends on the probe.

# Probing systems with RDS articulating head

#### NOTICE

The articulating head is, in this case, the probe carrier.

#### **Contact probing systems:**

Articulating head	RDS			
Probe	RST-P	XDT and VAST XXT <sup>1</sup>	SP25M	SP600
RDS adapter plate <sup>2</sup>	×	×	×	×
Optical probe				
Probe	×	×	×	×
Probe extension	<b>O</b> <sup>3</sup>	0	0	0
Adapter plate		×	×	×

Articulating head	RDS			
Probe	RST-P	XDT and VAST XXT <sup>1</sup>	SP25M	SP600
Stylus / Stylus system	×	×	×	×
<sup>1</sup> In combination with RD	S, only called XX	T: RDS / XXT.		
<sup>2</sup> The version of the RDS a	adapter plate dep	ends on the probe.		
<sup>3</sup> o: Option				

#### **Optical probing systems:**

Articulating head	RDS		
Probe	ViScan	DTS	LineScan
RDS adapter plate <sup>1</sup>		×	
Optical probe	x <sup>2</sup>	×	×

<sup>1</sup> The version of the RDS adapter plate depends on the probe.

<sup>2</sup> Consisting of the basic body of the camera, objective and lighting fixture.

# **Probing systems with Renishaw probe carriers**

A non-adjustable probe receptacle and articulating heads exist. For the articulating heads, a distinction is made between manual and electrical articulating heads.

### **Probe carrier versions:**

Probe receptacle:	PH6
Articulating head, manual:	MH8, MIH
Articulating head, electrical:	PH50, PH10

The following probes can be mounted to all probe carriers: TP6, TP2, TP20, TP200. For more information, please refer to the following table:

#### **Probes:**

	TP6	TP2	<b>TP20</b>	<b>TP200</b>
Probe extension	<b>0</b> <sup>1</sup>	ο	ο	0
Probe module			×	×
Stylus / Stylus system	×	×	×	×
<sup>1</sup> o: Option				

# **Functions of the components**

Probing

The *stylus* is used for probing the workpiece. The combination of several styli comprises a stylus system. The stylus system is mounted on an adapter plate. Afterwards, the adapter plate and the stylus system form a single unit.



Holding + securing	The <i>adapter plate</i> is used to hold one or more styli and to fasten them to the probe. Proper fastening is ensured by means of a <i>three-point bearing</i> . The adapter plate is held by a <i>magnet</i> integrated in the adapter plate receptacle of the probe.
	A <i>pin</i> located on the adapter plate receptacle is mated to a recess on the edge of the adapter plate. The adapter plate must be inserted in the adapter plate receptacle so that the pin fits into this recess.
	The <i>RDS adapter plate</i> is used to hold the probe. The RDS adapter plate is inserted in the articulating head and held by a magnet. The groove in the adapter plate enables correct positioning. The pin in the adapter plate receptacle of the RDS articulating head must engage in this groove.
	<b>NOTICE</b> There are RDS adapter plates with different probe connections.
Registration + transmis- sion	The <i>probe</i> holds the adapter plate and the mounted styli. Furthermore, the probe registers the deflection of the adapter plate and the stylus during probing. A signal is sent to the computer after each deflection.

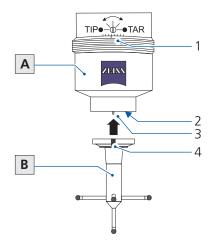
# **Contact probing systems**

# **ST probing system**

# Application

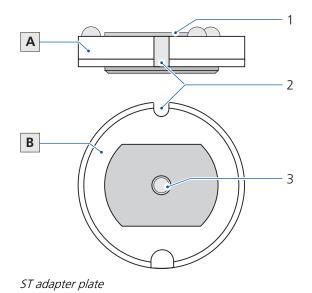
The ST probing system is used to probe discrete points. It enables the fast measurement of discrete points. Based on the measuring data, information can be obtained on the distances between two points or two planes.

# Components



- A ST probe
- **B** Stylus system adapter plate with star stylus
- 1 Possible adjustments for counterbalancing the stylus system
- 2 Adapter plate receptacle
- 3 Pin for positioning the stylus system
- 4 Recess for positioning the stylus system

# **Adapter plate**



- A Side view
- **B** Bottom view
- 1 Anchor plate
- 2 Groove for pin in the probe adapter plate receptacle; the pin allows correct positioning of the adapter plate.
- 3 M5 threaded hole for stylus system components, e.g. styli

# Limit values



A maximum weight of 200 g can be suspended from the adapter plate receptacle including the adapter plate. The length of the stylus system including extension must not exceed 200 mm.

# Counterbalancing

Manual counterbalancing is required for the ST probing system. A stylus system must be inserted in the adapter plate receptacle before beginning counterbalancing.

Counterbalancing is a method of compensating for the weight of the stylus system.



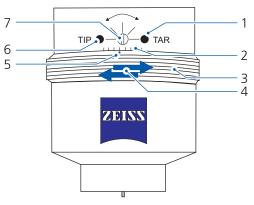
**Damage to the probe when overturning the adjusting screw.** Do not exert any force when rotating the adjusting ring. The index mark

must be located between the left and right graduation marks.

• Rotate the adjusting ring until the index mark is below the left or right graduation mark.

2-7

Definition



Counterbalancing of the ST probe

- 1 TAR LED for counterbalancing
- 2 Graduation marks
- 3 Adjusting ring
- 4 Directions of rotation of the adjusting ring
- 5 Mark on the adjusting ring
- 6 TIP LED for probing
- 7 Adjusting screw for fine counterbalancing

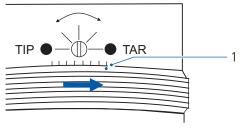
# No counterbalancing if...

Counterbalancing is *not* required in the following cases:

- With heavy stylus systems weight is within the max. permissible weight range.
- In case of automatic probe change also with small, lightweight probing systems.

# **Default setting**

Measurement with the standard setting is possible in both cases. Turn the adjusting ring clockwise to its right-hand stop. In this case, the LED does not light up.



Default setting for counterbalancing

1 Default setting: Index mark below right graduation mark.

# Counterbalancing is required if ...

Counterbalancing is necessary in the following cases:

## Conditions for counterbalancing

- Manual stylus system change
- Small lightweight stylus system
- LED lights up

Proceed as follows:

- **1** Turn the adjusting ring counterclockwise until the LED lights up.
- **2** Turn the adjusting ring clockwise until the LED switches off. Then turn the adjusting ring one or two graduation marks further.

#### NOTICE

The acceleration of the axes (X, Y, Z) can be reduced for further optimization. See operating instructions for the measuring software.

## Fine counterbalancing

Most measurements can be carried out with the adjusting screw in the standard position (slot of the screw is in vertical position). With longer and very thin styli, it may be necessary to use a different position.



#### Damage to the probe when overturning the adjusting screw.

• Turn the screw carefully and do not exert any force.

#### When should fine counterbalancing be carried out?

- If, while moving the CMM, the TIP LED lights up shortly several times, the fine counterbalancing adjustment is set too sensitive. The computer might not be able to record the measured data.
- If the fine counterbalancing is set to the insensitive setting, measurement recording may then be blocked. This may lead to deformation of the stylus shaft or the workpiece.

#### Adjusting the sensitivity of the fine counterbalancing

- **1** Turn clockwise to increase the sensitivity.
- 2 Turn counterclockwise to reduce the sensitivity.

#### NOTICE

You must correct the sensitivity adjustment until the error no longer occurs.

# ST 3 probing system



ST 3 probe with star stylus

# Application

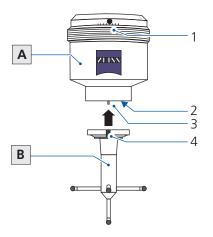
The ST 3 probing system is used to probe discrete points.

The probing system is preferably used ...

- for measuring large, metallic workpieces,
- if long, heavy stylus systems are used.

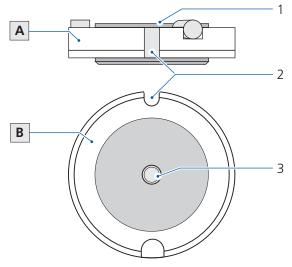
Furthermore, it also enables the fast measurement of discrete points. Based on the measuring data, information can be obtained on the distances between two points or two planes.

# Components



- A ST 3 probe
- **B** Stylus system adapter plate with star stylus
- 1 Adjusting ring for counterbalancing the stylus system
- 2 Adapter plate receptacle
- 3 Pin for positioning the adapter plate
- 4 Recess for positioning the adapter plate

# Adapter plate



ST 3 adapter plate

- A Side view
- B Bottom view
- 1 Anchor plate
- 2 Groove for pin in the probe adapter plate receptacle; the pin allows correct positioning of the adapter plate.
- 3 M5 threaded hole for stylus system components, e.g. styli.

# **Limit values**



A maximum weight of 200 g can be suspended from the adapter plate receptacle including the adapter plate. The length of the stylus system including extension must not exceed 200 mm.

# Counterbalancing

Manual counterbalancing is required for the ST3 probing system. A stylus system must be inserted in the adapter plate receptacle before beginning counterbalancing.



#### Definition

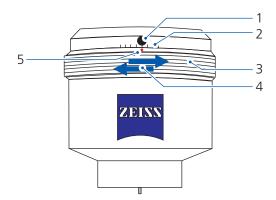
Counterbalancing is a method of compensating for the weight of the stylus system.



Damage to the probe when overturning the adjusting screw.

Do not exert any force when rotating the adjusting ring. The index mark must be located between the left and right graduation marks.

• Rotate the adjusting ring until the index mark is below the left or right graduation mark.



Counterbalancing of the ST 3 probe

- 1 LED
- 2 Graduation marks
- 3 Adjusting ring
- 4 Directions of rotation of the adjusting ring
- 5 Mark on the adjusting ring

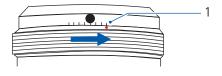
#### No counterbalancing if...

Counterbalancing is *not* required in the following cases:

- With heavy stylus systems weight is within the max. permissible weight range.
- In case of automatic probe change also with small, lightweight probing systems.

# **Default setting**

Measurement with the standard setting is possible in both cases. Turn the adjusting ring clockwise to its right-hand stop. In this case, the LED does not light up.



1 Default setting: Index mark below right graduation mark.

# Counterbalancing is required if ...

Counterbalancing is necessary in the following cases:

- Manual stylus system change
  - Small lightweight stylus system
  - LED lights up

Conditions for counter-

balancing

Proceed as follows:

- **1** Turn the adjusting ring counterclockwise until the LED lights up.
- **2** Turn the adjusting ring clockwise until the LED switches off. Then turn the adjusting ring one or two graduation marks further.

## NOTICE

The acceleration of the axes (X, Y, Z) can be reduced for further optimization. See operating instructions for the measuring software.

# **XDT probing system**



XDT probe

# Application

The XDT probe can be used universally. Only discrete points can be probed. Scanning is not possible. Measurements performed with this system provide information on the dimensions, position and form of a workpiece.

# Characteristics

- Automatic stylus system change
- Low deviation by measuring system
- Robustness

# Application

The XDT probe can be used in two ways:

- in combination with the RDS articulating head > See [ $\Rightarrow$  2-42]
- as central probe on a rigid adapter.

The adapter is attached to the ram. The second possibility is not possible for all CMMs.



# System requirements

To perform measurements using the XDT probe, the following requirements must be met:

	XDT with TL3
Measuring software:	from CALYPSO 4.10.02
Firmware:	from 22.09

Only TL3 adapter plates can be used with the XDT probe. The plate designation is: »ZSH-28-B-0-M3ZSH-28-B-REF-TL3-M3ZSH-28-B-75-M3«.

# Version

# Standard

The XDT probing system comprises:

- XDT TL3 probe for stylus lengths from 30 to 150 mm
- Two adapter plates:
  - ZSH-28-B-0-M3
  - ZSH-28-B-REF-TL3-M3 (for master stylus)
- Master stylus (ThermoFit):

Length: 30 mm; diameter of the stylus tip: 5 mm

- Stylus (ThermoFit):

Length: 50 mm; diameter of the stylus tip 3 mm

Installation kit

The installation kit consists of a pin wrench  $5 \times 1.2$  and a probe key to screw on styli.

#### Option

Further optional components are:

RDS / VAST XXT adapter plate	Only in combination with the RDS articulating head
VAST XXT changer rack	One unit with three holders for the stylus holder.
	The unit is mounted on the profile rail of a changer rack.
Stylus kit	There are three different stylus sys- tem kits.

#### NOTICE

For conversions of a CMM, you may require additional conversion parts. Moreover, the system requirements must be met.

# Components





- 1 Adapter; attached to ram
- 2 LED; 3 pieces

Left. LED for probe; permanently lit if probe is connected to the adapter

*Center*: System clock pulse LED

Right: Power LED; permanently lit

- 3 Knurled ring for screwing to adapter
- 4 XDT probe
- 5 Adapter plate receptacle

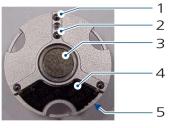
#### Adapter plate

The adapter plate is held magnetically and can be inserted manually or automatically. The three outer spheres on the adapter plate serve for adjustment of the correct position in the adapter plate receptacle. The correct fit of these spheres is monitored electronically. The fourth sphere serves for mechanical coding of the adapter plate type.

Marking

Laterally on the adapter plate, there are black markings at a distance of 120°. The markings are in the form of one, two or three dots. They serve for a better orientation when inserting the adapter plate.





TL3 adapter plate

- 1 Outer spheres serve for monitoring the correct position of the adapter plate in the adapter plate receptacle.
- 2 The inner sphere serves for mechanical coding
- 3 Magnet
- 4 Chip for marking the adapter plate
- 5 Lateral marking on the adapter plate; for orientation

#### NOTICE

Only adapter plates of the »ZSH-28-B« type may be used on the probe.

#### NOTICE

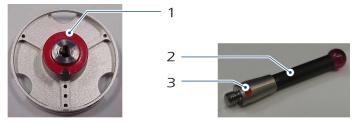
The correct fit of the adapter plate must be checked. Try to twist the adapter plate carefully. If you feel a slight resistance, the adapter plate fits correctly in the receptacle of the probe.

#### Adapter plate for master stylus

#### NOTICE

The adapter plate for the master stylus is identified by a red ring; the master stylus by a red dot. The XDT TL3 adapter plate for the master stylus has the following designation: »ZSH-28-B-REF-TL3«.

Use this adapter plate exclusively for the master stylus. Use the adapter plate and the master stylus only for qualification of the reference sphere (reference measurement).



Adapter plate with master stylus

- 1 Red ring on the adapter plate for master stylus
- 2 Master stylus for TL3
- 3 Red dot for marking of the master stylus.

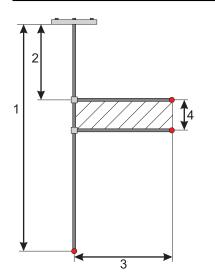


# **Limit values**

The following values must not be exceeded:

# Limit values for TL3:

Probe extension between RDS adapter plate and XDT probe	100 mm
Stylus system weight, max. (incl. adapter plate)	15 g
Total length of the stylus	30 mm - 150 mm



Conditions for lateral styli with the TL3

- 1 Stylus length: max. 150 mm
- 2 Distance from the adapter plate: min. 50 mm
- 3 Projection: max. 65 mm
- 4 Recommended range for lateral stylus: 50 70 mm

# Maximum deflection at the stylus tip

The maximum deflections depend on the length and weight of the stylus system as well as on the probe orientation. If the stylus sags in the Z direction at lateral orientation, the deflection in the -Z direction is reduced and increases in the +Z direction. Additionally, the maximum deflections in the other directions change.

# Deflection with a stylus length of 150 mm:

X, Y axis:	± 3 mm
Z axis:	± 3 mm



#### NOTICE

Only the styli belonging to the respective stylus kit may be used. If longer or heavier styli are used, this may result in measuring errors.

# VAST XXT probing system



VAST XXT probe

# Application

The VAST XXT probing system can be used universally. It is possible to probe discrete points or perform scanning. Measurements performed with this system provide information on the dimensions, position and form of a workpiece.

## Characteristics

- Scanning
- Automatic stylus system change
- Low deviation by measuring system
- Robustness
- Different probe variants are available depending on the stylus length and application

Measuring soft workpieces The VAST XXT is particularly suitable for measuring soft workpieces. Due to the low measuring force, deformations on the workpiece and thus incorrect measurements are avoided.

# Use

The VAST XXT can be used in two ways:

- in combination with the RDS articulating head. > See [ $\Rightarrow$  2-42]
- as central probe on a rigid adapter.

The adapter is attached to the ram. The second possibility is not possible for all CMMs.

# System requirements

To perform measurements using the VAST XXT probe, the following requirements must be met:

	TL1, TL2	TL3
Measuring soft- ware:	from CALYPSO 4.4	from CALYPSO 4.8.06
Firmware:	from 19.03	from 20.12

# **Design versions**

The VAST XXT is available in three design versions. Each version has certain accessories:

#### **Design versions**

Version 1 for stylus lengths from 30 to 125 mm:		VAST XXT TL1 probe Adapter plate for TL1
	_	Master stylus (ThermoFit):
		Length: 30 mm; diameter of the stylus tip: 5 mm
Version 2 for stylus lengths from 125 to 250 mm:	-	VAST XXT TL2 probe
	-	Adapter plate for TL2 (with ba- sic extension 75 mm)
	_	Master stylus (ThermoFit):
		Length: 50 mm; diameter of the stylus tip: 5 mm
Version 3 for stylus lengths from 30 to 150 mm:	_	VAST XXT TL3 probe
	_	Adapter plate for TL2
	-	Master stylus (ThermoFit):
		Length: 30 mm; diameter of the stylus tip: 5 mm

All versions are supplied with an additional adapter plate, an additional stylus and an installation kit. The installation kit consists of a pin wrench  $5 \times 1.2$  and a probe key to screw on styli.

Further components are:

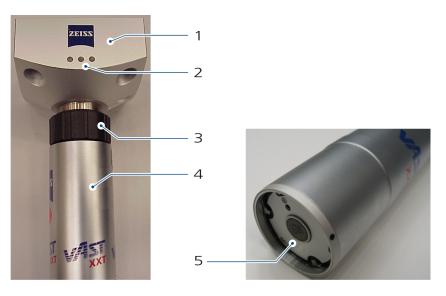
RDS/VAST XXT adapter plate	Only in combination with the RDS articulating head.
VAST XXT changer rack	One unit with three holders for the adapter plate.
	The unit is mounted on the profile rail of a changer rack.
Stylus kit	There are three different stylus sys- tem kits.



#### NOTICE

For conversions of a CMM, you may require additional conversion parts. Moreover, the system requirements must be met.

## Components



- 1 Adapter; attached to ram
- 2 LED; 3 pieces

Left. LED for probe; permanently lit if probe is connected to the adapter

*Center*: System clock pulse LED

Right: Power LED; permanently lit

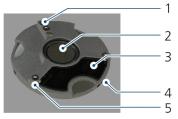
- 3 Knurled ring for screwing to adapter
- 4 VAST XXT probe
- 5 Adapter plate receptacle

#### Adapter plate

The adapter plate is held magnetically and can be inserted manually or automatically. The three outer spheres on the adapter plate serve for adjustment of the correct position in the adapter plate receptacle. The correct fit of these spheres is monitored electronically. The fourth sphere serves for mechanical coding of the adapter plate type.

Marking

Laterally on the adapter plate, there are black markings at a distance of 120°. The markings are in the form of one, two or three dots. They serve for a better orientation when inserting the adapter plate. A special adapter plate is provided for each design version.



Adapter plate for TL1

1 The inner sphere serves for mechanical coding of the different adapter plates; an adapter plate for TL1 is shown here.

With TL2, the inner sphere is even closer to the magnet.

- 2 Magnet
- 3 Chip for marking the adapter plate
- 4 Lateral marking on the adapter plate; for orientation
- 5 Outer spheres serve for monitoring the correct position of the adapter plate in the adapter plate receptacle.

#### NOTICE

The arrangement of the pair of spheres is different in TL1 and TL2. This prevents accidental insertion of a wrong adapter plate into the probe.

#### NOTICE

The correct fit of the adapter plate must be checked. Try to twist the adapter plate carefully. If you feel a slight resistance, the adapter plate fits correctly in the receptacle of the probe.

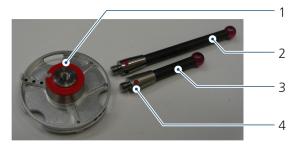
#### NOTICE

The 18-pole VAST XXT probe requires an adapter plate with ID chip. Adapter plates without ID chip are no longer supported.

#### Adapter plate for master stylus

#### NOTICE

The adapter plate for the master stylus is identified by a red ring; the master stylus by a red dot. Use this adapter plate exclusively for the master stylus. Use the adapter plate and the master stylus only for qualification of the reference sphere (reference measurement).



Adapter plate for TL1

- 1 Red ring on the adapter plate for master stylus
- 2 Master stylus for TL2
- 3 Master stylus for TL1
- 4 Red dot for marking of the master stylus.

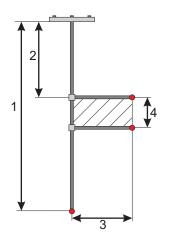
**TL2 adapter plate** The illustration shows a TL1 adapter plate. The adapter plate for TL2 has a firmly attached extension.

## **Limit values**

The following values must not be exceeded:

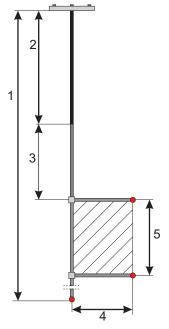
Probe extension (between RDS adapter plate and VAST XXT probe)	TL1, TL2, TL3	100 mm
Stylus system weight, max. (incl. adapter plate)	TL1 and TL2	10 g
	TL3	15 g
Total length of the stylus	TL1	30 mm - 125 mm
	TL2	125 mm - 250 mm
	TL3	30 mm - 150 mm

## **Conditions for lateral styli**



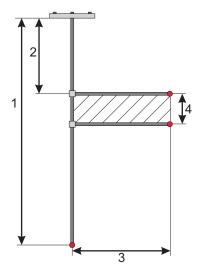
Conditions for lateral styli with the TL1

- 1 Stylus length: max. 125 mm
- 2 Distance from the adapter plate: min. 50 mm
- 3 Projection: max. 40 mm
- 4 Recommended range for lateral stylus: 50 70 mm



Conditions for lateral styli with the TL2

- 1 Stylus length: max. 250 mm
- 2 Fixed extension: 75 mm
- 3 Distance from the adapter plate extension: min. 50 mm
- 4 Projection: max. 40 mm
- 5 Recommended range for lateral stylus: 125 175 mm



Conditions for lateral styli with the TL3

- 1 Stylus length: max. 150 mm
- 2 Distance from the adapter plate: min. 50 mm
- 3 Projection: max. 65 mm
- 4 Recommended range for lateral stylus: 50 70 mm



## Maximum deflection at the stylus tip

The maximum deflections depend on the length and weight of the stylus system as well as on the probe orientation. If the stylus sags in the Z direction at lateral orientation, the deflection in the -Z direction is reduced and increases in the +Z direction. Additionally, the maximum deflections in the other directions change.

TL1	Deflection with a stylus length of 125 mm:	
	X,Y axis:	± 3.5 mm
	Z axis:	± 2.8 mm
TL2	Deflection with a stylus length of 250 mm:	
	X, Y axis:	± 3 mm
	Z axis:	± 3 mm
TL3	Deflection with a stylus length of 150 mm:	
	X, Y axis:	
	Z axis:	

#### NOTICE

Only the styli belonging to the respective stylus kit may be used. If longer or heavier styli are used, this may result in measuring errors.

## DT DynaTouch and VAST XT probing systems



DT DynaTouch probe



VAST XT gold probe



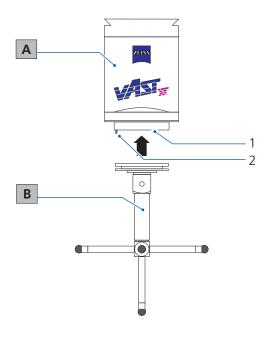
VAST XT probe



## Application

DT DynaTouch	The DT DynaTouch probing system is used to probe discrete points. Measurements performed with this system provide information on the di- mensions and position of a workpiece.
	Special applications:
	<ul> <li>In case of adverse ambient conditions: e.g. vi- brations (floor vibrations and sound).</li> </ul>
	<ul> <li>If high accuracy is required.</li> </ul>
	<ul> <li>If high repeatability is required.</li> </ul>
	<ul> <li>If long, heavy stylus systems are used.</li> </ul>
VAST XT	The VAST XT probing system can be used univer- sally. Compared with the DT DynaTouch probing system, multipoint measurements and scanning are also possible with this probing system. Meas- urements performed with this system provide in- formation on the dimensions, position and form
	of a workpiece.

## Components



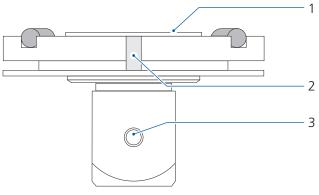
- A VAST XT probe (alternatively DT DynaTouch or VAST XT gold
- **B** Stylus system with adapter plate



- 1 Adapter plate receptacle
- 2 Pin for positioning the stylus system

## Adapter plate

The VAST adapter plate is provided with a distributor with five threaded holes used for mounting stylus system components. The size of the connection thread is M5.



VAST adapter plate

- 1 Anchor plate
- 2 Groove for pin in the probe adapter plate receptacle; the pin allows correct positioning of the adapter plate.
- 3 M5 threaded hole for stylus system components, e.g. styli.

## **Limit values**



A maximum weight of 500 g can be suspended from the adapter plate receptacle including the adapter plate. The length of the stylus system including extension must not exceed 500 mm.

#### Torque

The maximum torque of the stylus system allowed is 0.3 Nm. Calculation of the torque:  $\blacktriangleright$  See [ $\Rightarrow$  3-12]



## **VAST XTR probing system**



VAST XTR probe

## Application

The VAST XTR probe is an actively measuring scanning probe.

The most important distinctive feature of the VAST XTR is the installed rotational axis. The stylus system can thus be rotated in angular steps of 15° in the Z axis. This enables positioning a stylus at the correct angle to the workpiece. In some cases, the rotary table is therefore not required.

The VAST XTR supports the VAST navigator and VAST performance options.

## System requirements

Currently, the VAST XTR can be used for the ACCURA II and PRISMO coordinate measuring machines. Use on other CMMs is planned.

To perform measurements using the probe, the following requirements must be met:

Measuring software:	from CALYPSO 5.2.14
Firmware:	from 26.12

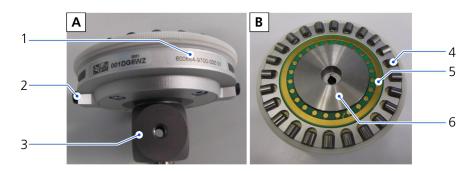
## Components



- 1 Dove tail for holding the ram
- 2 Probe
- 3 Adapter plate receptacle
- 4 Rotational axis with pin for securing the adapter plate

## **Adapter plate**

To use the rotation function on the VAST XTR probe, a special adapter plate is needed. The designation is: »ZSH-70-R-24« (order number: 600664-9700).



- A Front view
- **B** Top view
- 1 Order number
- 2 Unlocking button (2 pieces)
- 3 Cube for mounting styli
- 4 Anchor plate for fastening to the adapter plate receptacle of the probe
- 5 Contacts for identifying the adapter plate
- 6 Cylindrical pins



#### NOTICE

The »ZCR 70« holder is needed for storage in the changer rack. The VAST holder is not allowed.

## **Limit values**

kg

A maximum weight of 500 g can be suspended from the adapter plate receptacle including the adapter plate. The length of the stylus system including extension must not exceed 350 mm.

## Torque

The maximum torque of the stylus system allowed is 0.15 Nm. Calculation of the torque:  $\rightarrow$  See [ $\Rightarrow$  3-12]

To achieve better reproducibility during stylus change, the stylus system should be balanced more precisely.

## VAST gold probing system



VAST gold probe with star stylus

## Application

The VAST gold probing system can be used universally. Measurements performed with this system provide information on the dimensions, position and form of a workpiece.

Special applications:

- In case of adverse ambient conditions: E.g. vibrations (floor vibrations and sound).
- For measuring many measuring points multipoint measurement, scanning.



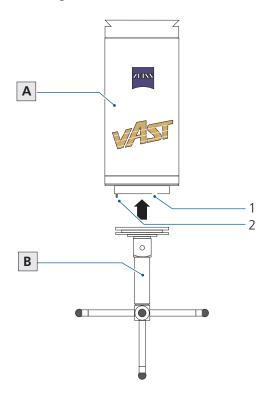
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- If high accuracy is required.
- If long, heavy stylus systems are used.

#### Special styli

In addition to conventional styli, a *temperature probe* may be used. The temperature probe is used to measure the workpiece temperature.

## **Components**

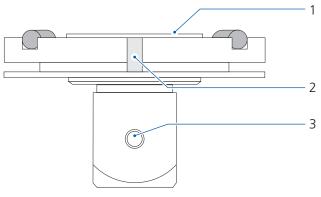


- A VAST gold probe
- **B** Stylus system with adapter plate
- 1 Adapter plate receptacle
- 2 Pin for positioning the adapter plate

## Adapter plate

The VAST adapter plate is provided with a distributor with five threaded holes used for mounting stylus system components. The size of the connection thread is M5.





VAST adapter plate

- 1 Anchor plate
- 2 Groove for pin in the probe adapter plate receptacle; the pin allows correct positioning of the adapter plate.
- 3 M5 threaded hole for stylus system components, e.g. styli

## **Limit values**

The limit values for weight, length and torque of a stylus system must be considered when assembling or mounting the stylus system.



A maximum weight of 800 g can be suspended from the adapter plate receptacle including the adapter plate. The length of a stylus system must not exceed 800 mm.

## Torque

The torque depends on the weight of the stylus system:

Weight of the stylus	К <sub>м</sub>	
800 g	0.1 Nm	
450 g	0.3 Nm	

Calculation of the torque: ► See [=> 3-12].

## **Temperature probe (option)**

## Application

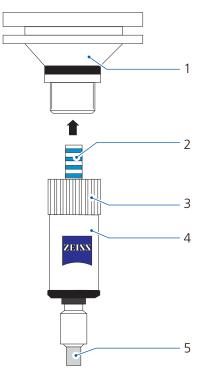
The temperature probe is used to measure the temperature of the workpiece surface and the surrounding air. Both measurements can also be carried out via a CNC program. Thus, temperature monitoring is possible throughout the entire measurement.

## NOTICE

The VAST probing system is required for the operation of a temperature probe.

Further information is given elsewhere. > See [ $\Rightarrow$  2-80] and > see [ $\Rightarrow$  2-81].

## Setup



RST-T temperature probe

- 1 Adapter plate
- 2 Connector
- 3 Knurled ring with internal thread
- 4 RST-T temperature probe
- 5 Temperature sensor



## **HSS probing system**



HSS probe

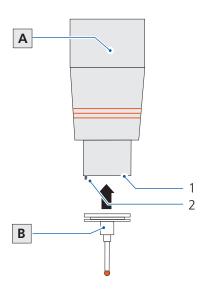
## Application

The HSS probing system can be used universally. Measurements performed with this system provide information on the dimensions, position and form of a workpiece.

Special applications:

- For measuring many measuring points multipoint measurement, scanning.
- If high accuracy is required.
- If long, heavy styli are used.

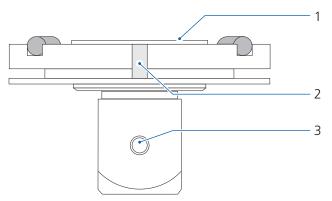
## Components



- A HSS probe
- **B** Stylus system adapter plate and stylus
- 1 Adapter plate receptacle
- 2 Pin for positioning the stylus system

## Adapter plate

The VAST adapter plate is provided with a distributor with five threaded holes used for mounting stylus system components. The size of the connection thread is M5.



VAST adapter plate

- 1 Anchor plate
- 2 Groove for pin in the probe adapter plate receptacle; the pin allows correct positioning of the adapter plate.
- 3 M5 threaded hole for stylus system components, e.g. styli.

## **Limit values**

The limit values for weight, length and torque of a stylus system must be considered when assembling or mounting the stylus system.



A maximum weight of 600 g can be suspended from the adapter plate receptacle including the adapter plate. The length of the stylus including extension must not exceed 600 mm.

## Torque

The maximum torque of the stylus system allowed is 0.2 Nm. Calculation of the torque:  $\blacktriangleright$  See [ $\Rightarrow$  3-14]



## **Contact probing systems with articulating** head

## **RDS probing system with RST**



## Application

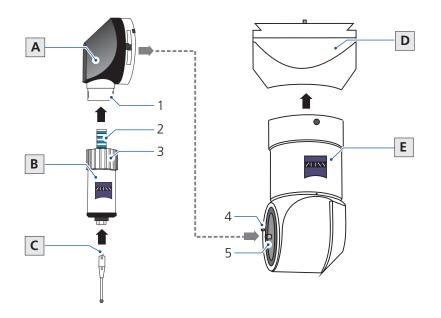
Discrete points are probed with trigger probes on the RDS articulating head. Probing is possible in almost any position. This is ensured by means of two rotary axes. The angular position in both axes can be changed in steps of 2.5°.

## **Special applications:**

- Probing of hard-to-access locations on the workpiece.
- Fast probing.
- Reduction of the number of styli: If many different stylus systems would be necessary for another probing system.

## Components

The RDS/RST probing system comprises an RDS incremental articulating head combined with an RST or RST-P probe. The articulating head is, in this case, the probe carrier.

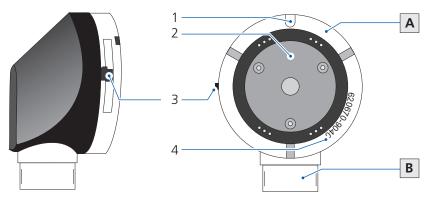


- A Adapter plate
- **B** RST or RST-P probe
- **C** Stylus with extension
- **D** Adapter for CMM with a 85 mm (width) ram
- E RDS articulating head
- 1 Connection thread for probe
- 2 Connector
- 3 Knurled ring with internal thread
- 4 Pin for positioning the adapter plate
- 5 Adapter plate receptacle

#### NOTICE

Self-centering probing is not possible for all CMMs. On some CMMs, the RDS is not directly connected to the ram.

#### Adapter plate



RDS/RST or RDS/RST-P adapter plate



- **A** Connection to the RDS articulating head
- **B** Connection of the probe or extension of the probe
- 1 Groove for positioning the adapter plate in the adapter plate receptacle of the RDS articulating head
- 2 Anchor plate
- 3 Push-button for releasing the adapter plate from the RDS articulating head
- 4 Order number of the adapter plate.

The RST or RST-P probe is fastened to the RDS adapter plate. You may put an extension between probe and adapter plate.

#### NOTICE

There are RDS adapter plates with different probe connections.

## **Limit values**



A maximum weight of 10 g can be suspended from the RST and RST-P probes. The length of the stylus system including extension must not exceed 90 mm.

## **RDS probing system with XDT**



XDT probe

## Application

The XDT probe can be used universally. Only discrete points can be probed. Scanning is not possible. Measurements performed with this system provide information on the dimensions, position and form of a workpiece.

The combination with the RDS allows probing in almost any position. This is ensured by means of two rotary axes. The angular position in both axes can be changed in steps of 2.5°.

## Characteristics

- Automatic stylus system change
- Low deviation by measuring system
- Robustness

## **System requirements**

To perform measurements using the XDT probe, the following requirements must be met:

	XDT with TL3
Measuring software:	from CALYPSO 4.10.02
Firmware:	from 22.09

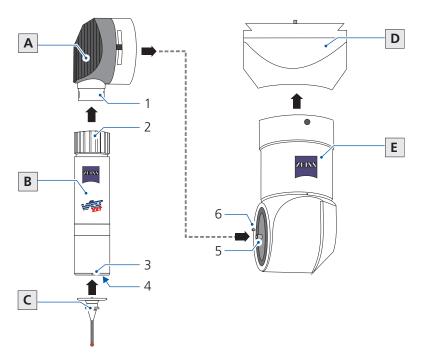
Only TL3 adapter plates can be used with the XDT probe. The plate designation is: »ZSH-28-B-0-M3ZSH-28-B-REF-TL3-M3ZSH-28-B-75-M3«.

## **Design versions**

Further information is to be found elsewhere ➤ See [⇒ 2-13].

## Components

The RDS/XDT probing system is a combination of the RDS articulating head and the XDT probe. The articulating head is, in this case, the probe carrier.





- A RDS-XXT adapter plate
- B XDT probe
- C Adapter plate for TL3; M3 thread
- D Adapter for CMM with a 85 mm wide ram.
- Е RDS articulating head
- Connecting thread for XDT 1
- 2 Knurled ring with internal thread
- 3 Marking for positioning the adapter plate
- 4 Adapter plate receptacle
- 5 Pin for positioning the RDS adapter plate
- Adapter plate receptacle 6

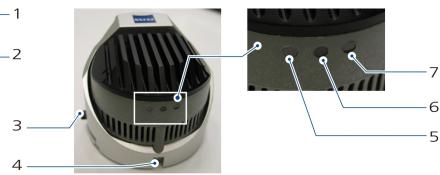
Information on the adapter plate, its receptacle and the master stylus can be found elsewhere. ➤ See [=> 2-15]

#### Adapter plate

The XDT probe is attached to the RDS-XXT adapter plate. Alternatively, an extension can be put between probe and adapter plate.



RDS-XXT adapter plate

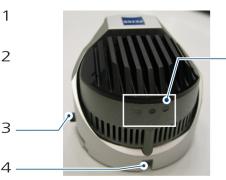


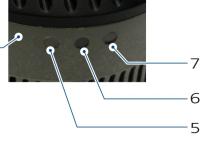
- 1 Connection to the RDS articulating head
- 2 Connection of the probe or extension of the probe
- Push-button for releasing the adapter plate from the RDS articulating head 3
- 4 Groove for positioning the adapter plate in the adapter plate receptacle of the RDS articulating head
- 5 Power LED; permanently lit
- 6 System clock pulse LED
- LED for probe; permanently lit if probe in RDS adapter plate 7

## Adapter plate

The XDT probe is fastened to the RDS/XXT adapter plate. Alternatively, an extension can be put between probe and adapter plate.







- 1 Connection to the RDS articulating head
- 2 Connection of the probe or extension of the probe
- 3 Push-button for releasing the adapter plate from the RDS articulating head
- 4 Groove for positioning the adapter plate in the adapter plate receptacle of the RDS articulating head
- 5 Power LED; permanently lit
- 6 System clock pulse LED
- 7 LED for probe; permanently lit if probe in RDS adapter plate

## Information about VAST XXT

#### NOTICE

When the RDS adapter plate is inserted for the first time into the adapter plate receptacle of the RDS, it is possible that the LED in the RDS will flash (above the ZEISS logo). The flashing of the LED indicates that the firmware of the adapter plate is being updated. The LED may flash for several minutes.

## **Limit values**

When using the XDT probe, certain limit values must not be exceeded. For more information, please refer to  $\succ$  See [ $\Rightarrow$  2-17]





## **RDS probing system with VAST XXT**

## Application

The VAST XXT probe can be used universally. It is possible to probe discrete points or perform scanning. Measurements performed with this system provide information on the dimensions, position and form of a workpiece.

The combination with the RDS allows probing in almost any position. This is ensured by means of two rotary axes. The angular position in both axes can be changed in steps of 2.5°.

## Characteristics

- Scanning
- Automatic stylus system change
- Low deviation by measuring system
- Robustness
- Different probe variants are available depending on the stylus length and application

#### Advantages

Measuring soft workpieces

The VAST XXT is particularly suitable for measuring soft workpieces. Due to the low measuring force, deformations on the workpiece and thus incorrect measurements are avoided.

## System requirements

To perform measurements using the VAST XXT probe, the following requirements must be met:



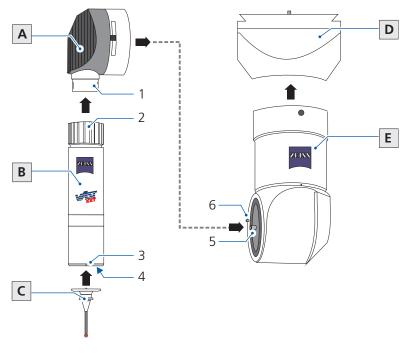
	TL1, TL2	TL3
Measuring software:	from CALYPSO 4.4	from CALYPSO 4.8.06
Firmware:	from 19.03	from 20.12

## **Design versions**

Further information is to be found elsewhere. ➤ See [⇒ 2-19]

## Components

The RDS/XXT probing system is a combination of the RDS articulating head and the VAST XXT probe. The articulating head is, in this case, the probe carrier.



- A RDS-XXT adapter plate
- B VAST XXT probe
- C Adapter plate for TL1; M3 thread
- D Adapter for CMM with a 85 mm wide ram.
- E RDS articulating head
- 1 Connecting thread for VAST XXT
- 2 Knurled ring with internal thread
- 3 Marking for positioning the adapter plate
- 4 Adapter plate receptacle



- 5 Pin for positioning the RDS adapter plate
- 6 Adapter plate receptacle

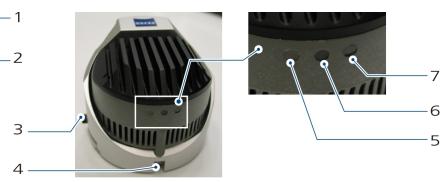
Information on the VAST XXT, i.e. adapter plate and master stylus, can be found elsewhere.  $\succ$  See [ $\Rightarrow$  2-20].

#### **RDS adapter plate**

The VAST XXT probe is fastened to the RDS-XXT adapter plate. Alternatively, an extension can be put between probe and adapter plate.



RDS-XXT adapter plate



- 1 Connection to the RDS articulating head
- 2 Connection of the probe or extension of the probe
- 3 Push-button for releasing the adapter plate from the RDS articulating head
- 4 Groove for positioning the adapter plate in the adapter plate receptacle of the RDS articulating head
- 5 Power LED; permanently lit
- 6 System clock pulse LED
- 7 LED for probe; permanently lit if probe in RDS adapter plate

## **Limit values**

When using the VAST XXT probe, certain limit values must not be exceeded. Further information is to be found elsewhere. > See [ $\Rightarrow$  2-22]

## RDS probing system with trigger Renishaw probes

## Application

Discrete points are probed with trigger probes on the RDS articulating head. Probing is possible in almost any position. This is ensured by means of two rotary axes. The angular position in both axes can be changed in steps of 2.5°.

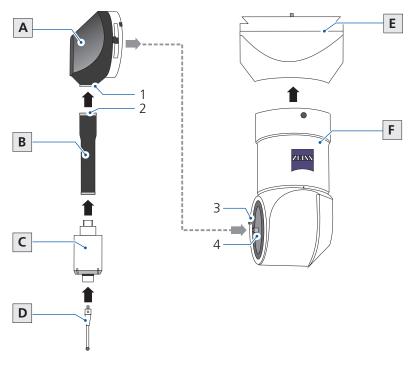


#### **Special features:**

- Probing of hard-to-access locations on the workpiece.
- Fast probing.
- Reduction of the number of styli: If many different stylus systems would be necessary for another probing system.

## Components

The RDS/Renishaw probing system is a combination of the RDS trigger articulating head and a Renishaw probe. There are different probes: e.g.TP6.

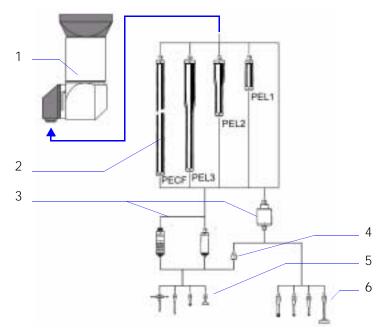


- A RDS / Renishaw adapter plate
- **B** RDS/Renishaw extension
- **C** Renishaw probe TP6
- **D** Stylus
- E Adapter
- F RDS articulating head
- 1 Connection of the Renishaw probe
- 2 Connecting thread
- 3 Pin for positioning the adapter plate
- 4 Adapter plate receptacle

2-45

#### NOTICE

Self-centering probing is not possible for all CMMs. On some CMMs, the RDS is not directly connected to the ram.

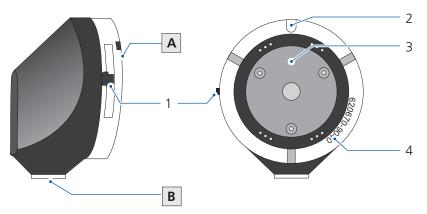


Possible combinations:

- 1 RDS articulating head, equipped with adapter and adapter plate
- 2 Extensions
- 3 Renishaw probes
- 4 SA3 (M3/M2 adapter)
- 5 Stylus with M2 thread
- 6 Stylus with M3 thread

#### **Adapter plate**

The Renishaw probe or an extension is attached to the RDS adapter plate. In the second case, the probe is attached to the extension.



RDS adapter plate for Renishaw probes and extensions



- A Connection to the RDS articulating head
- **B** Connection of Renishaw probe
- 1 Push-button for releasing the adapter plate from the RDS articulating head
- 2 Groove for positioning the adapter plate in the adapter plate receptacle of the RDS articulating head
- 3 Anchor plate
- 4 Order number of the adapter plate

## **Renishaw limit values**

The limit values for Renishaw probes can be found in the accompanying Renishaw brochures.

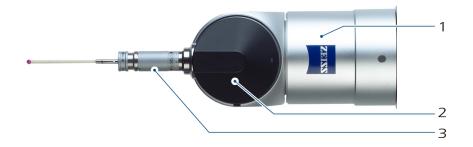
#### NOTICE

Only use the delivered stylus in order to reach the maximum probe accuracy possible.

## **RDS with TP200**

Components:

- RDS adapter plate for TP200
- TP200 probe
- PI200 interface



- 1 RDS articulating head
- 2 RDS adapter plate for TP200
- 3 TP200 probe with probe module



#### Damage to strain sensors.

The TP200 probe is provided with strain sensors. These are sensitive to shocks and may easily be damaged.

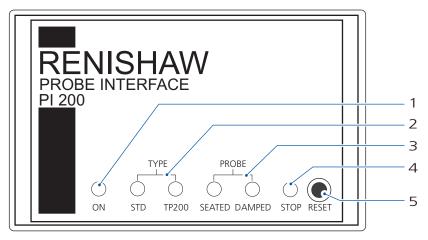
• Treat the TP200 probe with care.



#### NOTICE

The PI200 interface is required for the TP200 probe.

#### PI200 interface

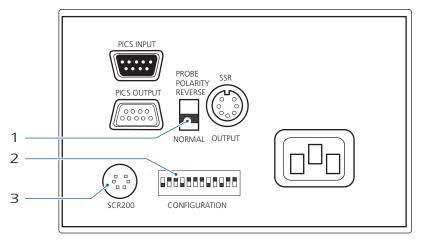


Front side of the PI200

- 1 Power supply «ON»
- 2 Display of the selected probe; «STD» = standard, e.g. TP2, TP6
- 3 Status display of the probe; «SEATED»: LED is lit = probe ready
- 4 «PICS-STOP» activated
- 5 Various functions, e.g. switching off an alarm sound

#### NOTICE

For more information, please refer to the separate PI200 interface brochure.



Rear side of the Pl200

- 1 Switch for polarity
- 2 Switch for configuration
- 3 Connection of the SCR200 changer rack



#### Switch for configuration

In order to measure with the TP200, the PI 200 interface must be configured correctly. Because there are different versions of the PI200 interface, the switches for the configuration can stand in different positions.

 Write down the position of the switches when installing the Pl200 and save this note on a safe place.

In case that the configuration is accidentally changed later on, you can reestablish the original configuration again.



Position of the switch

the polarity.

# Switch for polarityThe TP200 probe is sensitive to switched polarity. In case of switched<br/>polarity, the indicators for «POWER» and «STOP» at the front of the Pl200<br/>interface are lit. At the back of the interface, there is a switch for switching

Move the switch to the other position (Reverse or Standard)
 See [⇒ 2-48].

The probe should now work.

## Order for mounting the TP200

## Mounting the probe

- **1** Switch off the power supply for the CMM and PI200 interface.
- **2** Mount the probe carrier on the ram. See operating instructions for the CMM.
- **3** Mount the probe to the probe carrier.

## **Removing the probe**

- **1** Switch off the power supply for the PI200 interface.
- **2** Then switch off the power supply for the CMM.
- **3** Remove the probe from the probe carrier.
- **4** Dismount the probe carrier from the ram.

## Changing the probe module

#### NOTICE

Faults may occur when changing the probe module. See Renishaw operating instructions.

## **Renishaw probing system - triggering**

## Application

Single points are probed with trigger Renishaw probes. Special applications:

Probing with small, short styli,

- probing with low probing forces,
- probing of soft materials, e.g. plastics.

Furthermore, the articulating heads allow probing of hardly accessible areas on the workpiece.

## **Possibilities**

There are various possibilities for Renishaw:

Component	Туре
Receptacle for probe	PH6
Articulating heads	MH8, MIH, PH10, PH50
Probe	TP6, TP2, TP200 or TP200 (only in combi- nation with CALYPSO or U-SOFT)
Extension	PEL 1, PEL 2, PEL 3 (50, 100 and 200 mm long)
Changer rack	MCR20 forTP20 and
_	SCR200 for TP200

## Examples

Clamping device on the ram with PH1 probe receptacle and TP6 probe



MIH articulating head with PEL 2 extension and TP6 probe



## Mounting of the stylus system

On Renishaw trigger probes, the stylus system is normally screwed directly into the probe.

## Limit values

The limit values for Renishaw probes can be found in the accompanying Renishaw brochures.

## NOTICE

Only use the delivered stylus in order to reach the maximum probe accuracy possible.

## TP200 probe



#### Damage to strain sensors.

The TP200 probe is provided with strain sensors. These are sensitive to shocks and may easily be damaged.

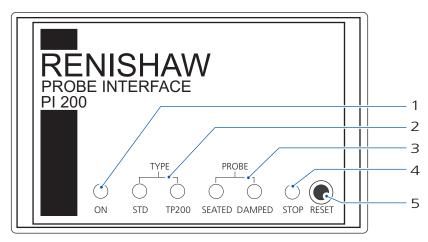
2-51

• Treat the TP200 probe with care.

#### NOTICE

The PI200 interface is required for the TP200 probe.

#### **PI200 interface**

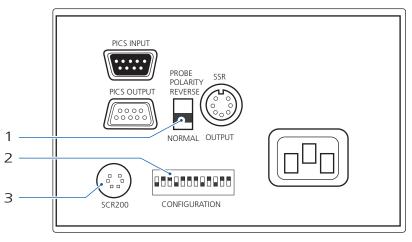


Front side of the PI200

- 1 Power supply «ON»
- 2 Display of the selected probe; «STD» = standard, e.g. TP2, TP6
- 3 Status display of the probe; «SEATED»: LED is lit = probe ready
- 4 «PICS-STOP» activated
- 5 Various functions, e.g. switching off an alarm sound

#### NOTICE

For more information, please refer to the separate PI200 interface brochure.



Rear side of the PI200

- 1 Switch for polarity
- 2 Switch for configuration
- 3 Connection of the SCR200 changer rack

#### Switch for configuration

In order to measure with the TP200, the PI 200 interface must be configured correctly. Because there are different versions of the PI200 interface, the switches for the configuration can stand in different positions.

 Write down the position of the switches when installing the Pl200 and save this note on a safe place.

In case that the configuration is accidentally changed later on, you can reestablish the original configuration again.



Position of the switch

# **Switch for polarity** The TP200 probe is sensitive to switched polarity. In case of switched polarity, the indicators for «POWER» and «STOP» at the front of the Pl200 interface are lit. At the back of the interface, there is a switch for switching the polarity.

Move the switch to the other position (Reverse or Standard)
 See [⇒ 2-48].

The probe should now work.

## Order for mounting the TP200

## Mounting the probe

- **1** Switch off the power supply for the CMM and PI200 interface.
- **2** Mount the probe carrier on the ram. See operating instructions for the CMM.
- **3** Mount the probe to the probe carrier.

#### **Removing the probe**

- **1** Switch off the power supply for the PI200 interface.
- 2 Then switch off the power supply for the CMM.
- **3** Remove the probe from the probe carrier.
- **4** Dismount the probe carrier from the ram.

## Changing the probe module

#### NOTICE

Faults may occur when changing the probe module. See Renishaw operating instructions.



## **RDS/SP25M probing system**

## Application

Discrete-point probing and scanning are possible using the SP25M probe. Probing is possible in almost any position. This is ensured by means of the two rotary axes of the RDS. The angular position in both axes can be changed in steps of 2.5°.

Special feature: Combination of variable adjustments with the articulating head and the scanning option. A further feature are the variable stylus lengths.

## System requirements

To perform measurements using the SP25M probe, the following requirements must be met:

#### System requirements for SP25M

Measuring software	CALYPSO 4.2
Firmware	18.06
Probe carrier	RDS

## Components

The RDS/SP25M probing system is a combination of the RDS incremental articulating head, the SP25M probe, a scanning module and an adapter plate. The articulating head is, in this case, the probe carrier.

## **Design versions**

Version 1 for stylus lengths from 50	) —	SP25M probe
to 105 mm:	_	SM25-2 scanning module
	_	SH25-2 adapter plate (2 pieces)
	_	Master stylus 20 mm
Version 2 for stylus lengths from	_	- Probe
120 to 200 mm:	_	SM25-3 scanning module
	_	SH25-3 adapter plate (2 pieces)
	-	Master stylus 20 mm

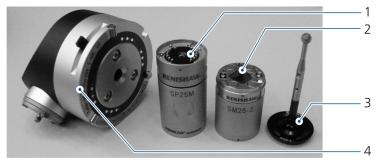
#### Additional components:

RDS adapter plate for SP series

FCR25 changer rack	3 holders for scanning modules and adapter plates. An adapter is needed for storing the adapter plates.
Stylus kit	There is a special stylus kit for each design version.

#### NOTICE

For conversions of a CMM, you may require additional conversion parts. Moreover, the system requirements must be met.



Components for SP25M

- 1 RDS adapter plate
- 2 SP25M probe
- 3 SM25-2 scanning module
- 4 SH25-2 adapter plate with stylus; M3 thread

There are different scanning modules. In turn, for each scanning module there is a special adapter plate.

#### **RDS/SP** adapter plate

The RDS/SP adapter plate is inserted into the adapter plate receptacle of the RDS articulating head in the same was as other RDS adapter plates.

#### NOTICE

When the RDS/SP adapter plate is inserted for the first time into the adapter plate receptacle of the RDS, it is possible that the LED in the RDS will flash (above the ZEISS logo). The flashing of the LED indicates that the firmware of the adapter plate is being updated. The LED may flash for several minutes.



#### SH25 adapter plate

For each scanning module there is a special adapter plate. The adapter plate is held magnetically and can be inserted manually or automatically. The orientation is determined by means of a sphere.

## **Limit values**

#### NOTICE

Only the styli belonging to the respective stylus kit may be used. If longer or heavier styli are used, this may result in measuring errors.

## Lateral styli

Lateral styli are only allowed for the scanning module SM25-2.

#### Conditions for lateral styli with the SM25-2:

Distance from the end of the	min. 20 mm
adapter plate extension:	
Projection:	max. 28 mm
Total length in the Z axis:	max. 105 mm

For more information, please refer to the operating instructions for the SP25M.

#### NOTICE

The SP25M probe is a Renishaw product. Separate operating instructions are provided for this. The operating instructions are included on the supplied CD as a pdf file. File name: »H-1000-5104-01-A (Draft V1) SP25M FCR25 AC3 - IIUG.pdf«.

Please read the information in the SP25M operating instructions.

## **RDS probing system with SP600**

## Application

Discrete-point probing and scanning are possible using the SP600 probing system. Probing is possible in almost any position. This is ensured by means of the two rotary axes of the RDS. The angular position in both axes can be changed in steps of 2.5°

Special feature: Combination of variable adjustments with the articulating head and the scanning option.

## System requirements

To perform measurements using the SP600 probe, the following requirements must be met:

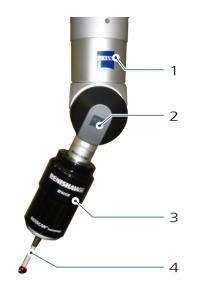
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Measuring software	CALYPSO 4.0
Firmware	16
Probe carrier	RDS

#### **System requirements for SP600**

## Components

The RDS/SP600 probing system is a combination of the RDS incremental articulating head and the SP600 probe. The articulating head is, in this case, the probe carrier.



- 1 RDS articulating head
- 2 RDS adapter plate
- 3 SP600 probe
- 4 Stylus; M4 thread

## NOTICE

The RDS probe and the RDS adapter plate form a unit. The probe and adapter plate must *not* be separated.

A test seal is located at the connection point between the probe and the adapter plate. This test seal must neither be removed nor damaged.

## Adapter plate

The RDS/SP adapter plate is inserted into the adapter plate receptacle of the RDS articulating head in the same way as other RDS adapter plates.



#### NOTICE

When the RDS/SP adapter plate is inserted for the first time into the adapter plate receptacle of the RDS, it is possible that the LED in the RDS will flash (above the ZEISS logo). The flashing of the LED indicates that the firmware of the adapter plate is being updated. The LED may flash for several minutes.

## Adapter plate

The adapter plate is held magnetically and can be inserted manually or automatically. The orientation is determined by means of a pin.



SP600 probe with adapter plate

- 1 Adapter plate receptacle
- 2 Magnet
- 3 Pin for positioning the adapter plate
- 4 Adapter plate
- 5 Groove for pin used for positioning

#### NOTICE

For long styli, a special adapter plate containing a stronger magnet is available from Renishaw. This adapter plate must be used when the permissible holding force is exceeded.

## Limit values



The maximum permissible stylus weight, including adapter plate, is 20 g. The maximum permissible stylus length is 200 mm.

For more information, please refer to the separate SP600 brochure.

#### NOTICE

Longer styli are permitted according to the separate brochure. Nevertheless, the above value for the maximum permissible stylus length should not be exceeded. Otherwise, inaccurate measurements may occur.



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```
Sensors
```

## NOTICE

The SP600 probe is a Renishaw product. An extra brochure is provided for the probe. This brochure is delivered together with the probe.

# **Optical probing systems with RDS**

## ViScan probing system

#### NOTICE

The ViScan probe is described in the separate brochure »Optical measurement« providing complete information on the use of the probe.

## Application

ViScan is an optical probe (image sensor with autofocus). It is used to measure parts for which contact probing is not possible.

The ViScan is inserted in the adapter plate receptacle of the RDS articulating head. Thus, probing in almost any direction is possible.

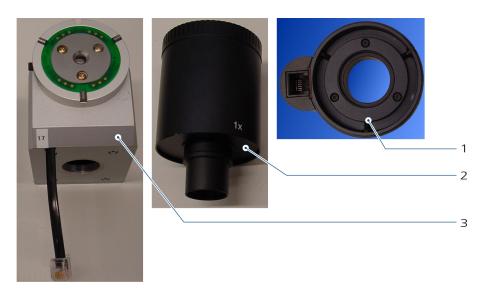
## System requirements

To operate the ViScan, the following requirements must be met:

#### **Prerequisites for ViScan**

Control	C99
Measuring software	CALYPSO
Probe carrier	RDS

## Components



- 1 Illumination unit
- 2 Objective
- 3 Camera body



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#### NOTICE

For the work with the ViScan, a transmitted light table is included in the accessories. This is a glass plate illuminated from below.

## **DTS diode probe**

## Application

DTS is an optical probe (triangulation sensor). It is used to measure parts for which contact probing is not possible.

The DTS is inserted in the adapter plate receptacle of the RDS articulating head. Thus, probing in almost any direction is possible.

## Components

The DTS consists of an adapter plate and a probe. Probing is acknowledged by LEDs.



## NOTICE

The probe of the DTS must *not* be unscrewed from the RDS adapter plate.

## LineScan probing system

LineScan is a system composed of the laser line scanner and software components. It is used for profile measurement, quality control and dimensional inspection.

The laser line scanner is inserted in the adapter plate receptacle of the RDS articulating head. This allows scanning in almost any direction.



## NOTICE

Separate operating instructions are available for LineScan providing complete information on the use of the probe.

## Prerequisites for LineScan:

Control	C99
Scan software	WBScan
Measuring software	CALYPSO or HOLOS
Probe carrier	RDS



# Information on the measuring operation

## Notes on the measuring run

## Checking the styli

Regular inspection of the stylus systems is required to ensure correct workpiece measurement.

- Check the styli, the stylus system components and the adapter plate regularly.
- Remove any particles or grease film from the stylus tips and the adapter plate.
- Replace any styli that are damaged.

## **Effect of magnetic fields**

#### NOTICE

Probes are sensitive to magnetic fields. This leads to stylus deflections and thus to measuring errors. Possible causes of a magnetic field: e.g. magnetic workpieces, clamping tool.

## Influence of temperature

## NOTICE

In order to carry out a temperature compensation between CMM and an inserted probe, an appropriate time period for this compensation has to be considered. This period depends on the temperature difference between the probe and CMM.

## **Types of measurement**

## **Overview**

Discrete-point probing, multipoint measurements and scanning are possible using the corresponding probing system. When scanning, it is differentiated between passive and active measuring probing systems.

	Discrete point	Multiple point	Scanning	
			Passive	Active
ST	×			
ST 3	×			
ST-ATAC	×			
DT DynaTouch	×			



	Discrete point	Multiple point	Scanning	
			Passive	Active
XDT	×	×		
VAST XXT	×	×	×	
VAST XT / VAST XT gold	×	×		×
VAST XTR	×	×		×
VAST / VAST gold	×	×		×
HSS	×	×		×
RDS with RST-P	×			
RDS with XDT	×			
RDS with VAST XXT	×	×	×	
RDS with TP6	×			
RDS with TP2	×			
RDS with TP20	×			
RDS with TP200	×			
RDS with SP25 or SP25M	×	×	×	
RDS with SP600	×	×	×	
RDS with ViScan	×			
RDS with DTS	×			
RDS with LineScan		×	×	
Renishaw, e.g. MIH, with TP6	×			

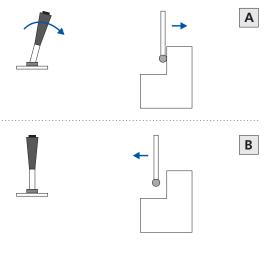
# **Discrete-point probing**

	Discrete-point probing means that only one point is probed. Then the probe moves away from the workpiece. This procedure must be repeated if additional points are to be probed.
Complete measurement	With discrete-point probing, a workpiece can be measured completely. All dimensions of the workpiece are calculated by means of the probed single points. No information can be obtained regarding form. For this, scanning and a special software are required.
	Probing with trigger probing systems
Acknowledgement by signal sound	A signal is sounded as soon as the measuring point probed is successfully transmitted to the measuring system. The joystick can then be released. The stylus automatically retracts in the direction opposite to the probing direction.



#### NOTICE

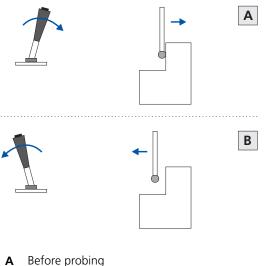
In case of a fault, the joysticks are re-enabled after about two seconds. The stylus can be moved back via joystick control. The stylus can be moved in all directions at low speed. The collision protection is *not* active.



- **A** Before probing
- В After probing

#### Probing with measuring probing systems

The stylus must be moved back contrary to the probing direction after each discrete-point probing.



- Α
- After probing В

## **Exact measured values**

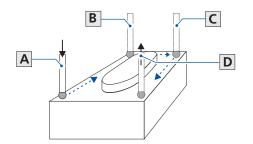
With measuring probing systems, many measured values are recorded in each probing. Using these values, the control calculates the exact measured value. This guarantees a low deviation and a high reproducibility.



## Multipoint measurement

Multipoint measurement is only possible with a measuring probing system. During multipoint measurement, the stylus, in the probing status, is moved perpendicular to the probing direction.

The probing axis runs parallel to the workpiece surface. During measurement, the stylus tip constantly remains in contact with the workpiece surface. The measuring force remains effective until probing is completed.



- A Lowering the stylus and probing the workpiece using the left joystick.
- B-D Move the stylus over the workpiece with the right joystick. The position in the Z axis remains unchanged.
- D Lifting the stylus.

You can influence the transfer of measured values individually. The measured value can be transferred either dynamically or statically.

 Dynamic measured value transfer (not possible with the C99 control unit and CALYPSO):

The measured value is immediately transferred by pressing the pushbutton of the right joystick. The stylus movement is not stopped.

- Static measured value transfer.

Each time the CMM stops traveling a measured value is created, but not transferred immediately. Measured value transfer occurs after a damping period of approx. one second (1 s).

**Terminating the multi-** To terminate the measurement, deflect the joystick counter to the prob**point measurement** ing direction.

## Scanning with VAST XT, VAST and HSS

During scanning, the surface of a workpiece is continuously probed. The measuring points make it possible to calculate surfaces or provide information on the form of a surface.

**No axis clamping** The axes of the probe are generally not clamped during scanning. This means that measurement takes place with freely movable axes.



Applying the measured

value

## Scanning modes:

VAST circle scanning:	for measuring shafts and bores whereby the CMM automatically differentiates between inside and outside bores.
VAST surface scanning:	for measuring surface-like work- piece areas.
VAST line scanning:	for flatness measurements or ac- quisition of curved shapes in pre- defined section planes. In this case, it is advisable to clamp one axis.

## **Special features of VAST gold and HSS**

Different measuring routines are available for each scanning mode:

#### Four VAST stages:

VAST stage 1:	Exact acquisition of dimensions, position and form.
	Scanning with maximum precision for measuring dimensions, form and position.
VAST stage 2:	Rapid acquisition of dimensions, position and form.
	Scanning with high dynamics for measuring dimensions, form and position ( $2 \times V_2$ ).
VAST stage 3:	Exact acquisition of dimensions and position.
	Scanning with maximum precision for measuring dimensions and po- sition.
VAST stage 4:	Rapid acquisition of the position.
	Scanning with maximum dynamics for measuring the position.

For more information, please refer to the operating instructions for the measuring software.

# Special features of the ST and ST3 probing system

## **Probing procedure**

The probing procedure is subdivided into three steps:

- 1. Contact with the workpiece
- 2. Generation of the probing pulse
- 3. Release of a mechanical switch

After contact, the probing pulse is generated. Then the stylus system starts to deflect. When the mechanical switch in the fixed part of the probe is released, the movement in the probing direction is stopped. The probe moves back. The deflected stylus system returns to its initial position.

## **Conditions for probing pulse**

The probing pulse is generated by a very small amount of force (F < 0.1 N). This occurs as soon as the stylus tip contacts the workpiece. Observe the following to ensure perfect probing results:

Probing path:	The travel path before the contact point must be at least 0.5 mm.
Probing speed:	The time between the probing pulse and the re- lease of the mechanical switch must be within a certain period. This means: The probing speed must exceed a certain value. The control console indicates when the probing speed is reached. An LED on the standard control console lights up.

#### NOTICE

If the probing speed is too low, the probing is not registered. The probing must be carried out again.

# Special features of the VAST XTR gold probing system

## Setting up the VAST XTR probe

## Setting up the probe and holder in the measuring software

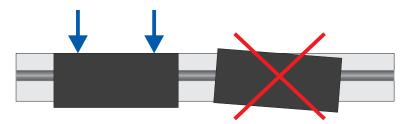
In the CALYPSO default settings, the probe must be set on the »Sensors« tab. Do do so, select »VAST-XTR«. Select the »ZCR« type when creating a new stylus system holder in CALYPSO. See operating instructions for the measuring software.

## Changing the position of a holder

To move a holder in the profile rail on the MSR changer rack, you must first slacken the two screws on the lower side of the holder.

- 1. Slacken the two screws on the lower side of the holder.
- 2. Move the holder to the desired position
- 3. Retighten the screws.

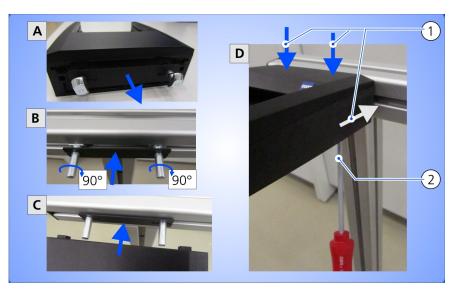
NOTICE! When tightening, the holder may tilt to the side. To avoid inclined mounting of the holder in the profile rail, you must push the holder downwards against the profile rail while tightening the screws.



Inclined holder due to incorrect mounting

Procedure for mounting the holder between two existing holders.

- 1. Remove the metal plate located on the rear side of the holder and the two holding pins **[A]**.
- 2. Slide the holding pins into the groove of the profile rail and turn by 90° **[B]**.
- 3. Slide the holder onto the two holding pins and retighten the screws **[C, 1, 2]**. See also note on point 3 above.



Mounting a holder between two holders

## Qualification

The holder can be qualified with a qualified stylus. The only condition is that the max. diameter of the stylus tip is 8 mm.

Qualification is a two-step procedure:



1. The qualification slope on the holder must be probed with a stylus. Then CALYPSO automatically recognizes the type of the holder and the approach direction in the holder.



Qualification slope 1

2. Now, the stylus length must be determined. To do so, probe any plane surface with the stylus tip and with the lower edge of the adapter plate.**NOTICE!** Make sure that the narrow outer ring is probed with the lower edge. See illustration.



Zone for probing 1

#### NOTICE

The adapter plate can only be loaded in one holder position. To do so, the adapter plate is automatically rotated to this position prior to loading.

The holders can be arranged such that approach in the  $\pm X$  and  $\pm Y$  directions is possible.

## Inserting and removing the adapter plate



The adapter plate must be inserted with mounted styli. No styli may be mounted on the inserted adapter plate. Otherwise, the probing system may become damaged.



For inserting the adapter plate in the VAST XTR probe, you must press both push-buttons on the adapter plate and keep them pressed. Then slightly push the adapter plate in horizontal position upwards into the adapter plate receptacle of the probe and release the push-buttons.



ZSH-70-R-24 adapter plate

1 Push-button for safety catch

## NOTICE

After manual change of the adapter plates, make sure that both pushbuttons return to their initial position. Otherwise, the adapter plate may not be recognized correctly in the system. Neither rotation nor probing is possible in this position.

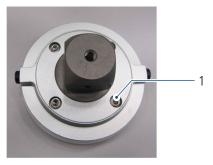
The current angular position of the adapter plates is automatically recognized after correct loading. The position in which the two type plates of the adapter plate point towards the front side of the probe defines the angular position «zero». See **[1]** below.



1 Home position of the adapter plate

The angular position can be changed in steps of 15°. Thus, a maximum of 24 positions is possible. Adaptation of the position of the probe mounting cube in smaller angular steps is possible by rotating the cube. To do so, the four screws on the lower side must be slightly loosened.





1 Screws for setting the angular position (4 pieces)

## NOTICE

You must retighten the four screws after setting the desired position. The torque is 1.5 Nm.

## **Removing the adapter plate**

The procedure for manual removal of the adapter plate is initiated by a command on the control console or the »Release stylus system« CALYP-SO function. At the same time, the two lateral push-buttons must be pressed and kept pressed. After the audible release of the holding magnet, the adapter plate can be removed downwards.

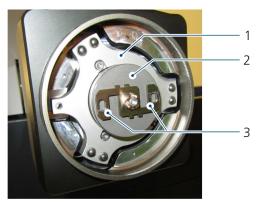
## **Collision protection**

The collision protection of the probe is partly integrated in the adapter plate.

## NOTICE

If short styli are mounted directly to the adapter plate, only limited protection against collision is provided for the VAST XTR at maximum travel speed.

If, in case of collision, the adapter plate moves away from the probe, the body and the styli are pulled off the adapter plate. The anchor plate remains on the probe. Furthermore, the locking slides also remain on the anchor plate.



VAST XTR adapter plate receptacle after a collision

- 1 Adapter plate receptacle
- 2 Anchor plate
- 3 Locking slides

The anchor plate can be removed from the probe using the »Release stylus system« function in CALYPSO. **NOTICE! The anchor plate can fall off automatically. Therefore, hold your hand under the anchor plate to prevent it from dropping on the measuring table.** 

## NOTICE

In the individual case, both locking slides must be pushed manually outwards and the anchor plate must be removed by pulling downwards.

Subsequent measures:

- 1. After more than 3 collisions, insert new annular springs in the groove of the anchor plate **[1+2]**.
- 2. Reinsert the correctly aligned locking slides [3].

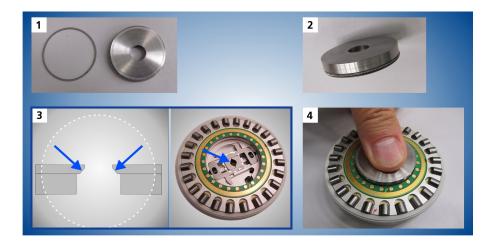
NOTICE! The beveled surfaces of the locking slides must point downwards.

3. Press the anchor disc into the adapter plate with the groove pointing downwards **[4]**.

## NOTICE

The replacement springs are included in the packaging of each adapter plate. Additional springs can be ordered as spare parts using the number 531-398.

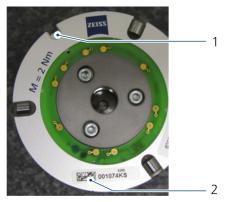




## Use of other adapter plates

The delivered adapter plate for the master stylus and the recent type of the VAST adapter plate can also be inserted into the adapter plate receptacle of the VAST XTR probe. These adapter plates can only be operated in the 0° position.

The usable VAST adapter plates can be recognized by a label with the DataMatrix code.

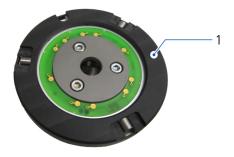


VAST adapter plate with DataMatrix code

- 1 Groove for correct positioning in the adapter plate receptacle
- 2 DataMatrix code

## **Collision protection**

Before using VAST adapter plates on the VAST XTR probe, the collision protection ring must be pressed onto the adapter plate. Otherwise, no collision protection is provided for the VAST XTR.



1 Collision protection ring (order number: 600664-0298-000)

## **Inserting adapter plates**

The delivered adapter plate for the master stylus and the VAST adapter plate may only be inserted in a certain position. To do so, the marked groove must point in the -X direction of the CMM coordinate system. **NOTICE!** In contrast to other VAST probes, the adapter plate receptacle of the VAST XTR probe is not fitted with a pin for correct insertion of the adapter plate. The adapter plate must therefore be inserted with care.

## NOTICE

If the adapter plate is accidentally inserted in the wrong position, the adapter plate will not be recognized. In this case, the adapter plate must be released and inserted again.

# Special features used for measuring probing systems

## Notes on measuring probing systems

The results of manual probings and measurements with CNC programs may slightly vary. In general, the highest precision can be achieved in the automatic mode with CNC programs.

## Precision positioning during probing

With measuring probing systems, the joysticks are temporarily deactivated as soon as the probe touches the workpiece. The CMM control takes over the precision positioning of the stylus. The measured value is accepted.

## Setting the measuring force

61211-6080802

The measuring force has to be set for the measuring probing systems. The value of the measuring force must be entered in the measuring software. See operating instructions for the measuring software.



Why does the measuring

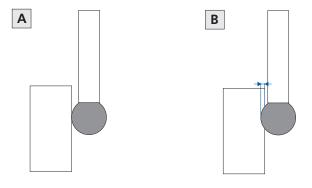
force have to be set?

#### NOTICE

The measuring force can be set individually for each stylus, if required.

During probing, the stylus tip can cause changes in the workpiece form. The extent of these form changes influences the precision of the calculated values. In order to avoid falsified measuring data, the measuring force should be adapted to the characteristics of the workpiece material.

Example: Greater changes in form can be expected with soft workpiece materials and high measuring force than with hard workpiece materials and low measuring forces. In this case, the measured value is falsified by the extent of the form change.



- A Nominal status: no workpiece deformation.
- **B** Falsified measurement due to indentation of the workpiece. Reason: soft material and high measuring force.
- 1 Extent of falsification

#### Information for VAST XT, VAST and HSS

The measuring force can be set continuously. Normally, a measuring force of 0.2 N has to be used for measurement. If larger form changes are to be expected, the measuring force should be 0.1 N.

– Set the measuring force according to your requirements.

#### NOTICE

With *self-centering probing*, a higher measuring force in the MAN operating mode might be useful in order to improve centering. ➤ *See* [⇔ 2-78]

Increase the measuring force if necessary.

#### Notes on other measuring probing systems

Adjustments of the measuring force and further particularities for the measuring operation are treated elsewhere.

 Please pay attention to the chapters dealing with the special features of the respective probing system.

0.2 N - normal

## Notes on scanning

## Scanning speed

The possible scanning speed depends on the measuring force, the surface condition of the workpiece, the radius of the stylus tip and the required tolerance.

#### NOTICE

Too high scanning speeds can lead to incorrect measuring results. The »navigator« software option offers you assistance for the choice of the optimum scanning speed.

**Measuring force** The measuring force depends on the probe and can be adjusted within certain limits with many probes.

## Abrasion or material deposits

#### NOTICE

During scanning, the stylus remains continuously in contact with the workpiece. The stylus tip practically glides along the surface of the workpiece. This may cause abrasion and material deposits.

Abrasion:	Material may rub off the workpiece or the stylus tip (e.g. in case of sintered material) as the stylus glides along the surface of the workpiece during probing.
Material deposits:	With certain materials (such as aluminum), mate- rial may remove itself from the workpiece and de- posit itself on the stylus tip.

For this reason, stylus tips should be checked regularly following all scanning operations and be replaced, if necessary.

**1** Check the condition of the stylus tips and clean them.

For information on how to remove aluminum deposits, please refer to the operating instructions for the CMM.

2 If the stylus tip is damaged, you must replace the stylus.

## **Axis clamping**

## What you should know?

With regards to *actively measuring* probing systems, axes can be clamped or unclamped.

Clamping and unclamping can be carried out via the measuring software and the control console. It is possible to unclamp one, two or all three axes.



## Why is clamping necessary?

You can cause the measuring force to act in a certain axis by clamping specified axes.

Two axes must be clamped when probing single points. The probe can be moved in the axis of the probing direction.

#### Notes

#### NOTICE

In general, the measurement has to be carried out with the same axis clamping as for qualification

*Example*: In case of unclamped axes, probing should be carried out using a stylus. This stylus must be qualified in the same way. This means: All axes must be unclamped during qualification of the stylus.

## Self-centering probing

If the probe can be moved freely in all axes, it will be centered automatically, e.g. a conical probe in a bore. A combination of one clamped and two unclamped axes is also possible.

#### NOTICE

All axes are unclamped via the basic settings of the measuring software. Axis clamping must be carried out via the control console or the measuring software. See operating instructions for the measuring software.

#### **Measuring force**

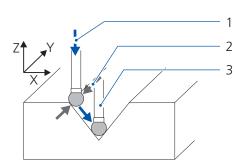
With self-centering probing, it may be advisable to increase the measuring force or to specify the direction in which the measuring force is to act. The direction is specified by clamping the axes in which probing should not take place.

Measuring software or<br/>control consoleThe measuring software makes it possible to alter the value of the measuring<br/>force and to specify the direction in which the measuring force is<br/>to act. The direction of the measuring force can also be set via the control<br/>console.

#### **Examples:**

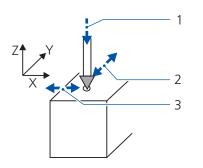
One axis clamped

Bottom of narrow V grooves.



- 1 Probing in the Z axis; moving axis.
- 2 Y axis is clamped; no movement possible in the Y axis.
- 3 Self-centering in the X axis up to the bottom of the groove.

**Three freely moving axes** Probing of a small bore with a conical probe.



- 1 Probing in the Z axis; moving axis.
- 2 The probe can move freely in the Y and X axes; the cone is automatically centered in the bore.

#### NOTICE

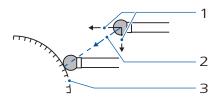
Self-centering probing is not possible for all measuring probing systems. Please pay attention to the chapters dealing with the special features of the respective probing system.

## All axes unclamped

*Vector probing* means that the probe can move freely in all three axes. This mode is generally selected in the basic settings of the measuring software.

Vector probing ensures optimum probing results for most measuring jobs. In the ideal case, the measuring force acts vertically on the surface being probed. Furthermore, exact correction of the probe bending is ensured.





- 1 Freely moving axis
- 2 Measuring force perpendicular to the workpiece
- 3 Workpiece

## NOTICE

To prevent any misunderstandings: The workpiece is not probed in two axes. In the manual mode, probing takes place in *one* axis of the workpiece coordinate system: either X, Y or Z. In a CNC program, probing takes place in the nominal vector direction.

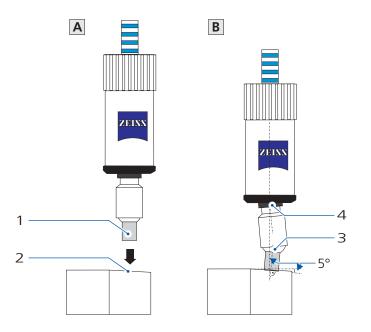
# **Temperature probe (option)**

## Notes on temperature measurement

- The temperature measurement should be carried out on thick-walled workpieces.
- The workpiece surface must be clean and flat.
- The surface to be probed should be larger than the contact surface of the temperature-sensing stylus.
- Measuring force: 1 N.
- The workpiece should be probed in the axis direction of the temperature probe.

The max. angle between the axis direction and the standards of the workpiece surface may no exceed  $\pm 5^{\circ}$ . Perfect measuring operation cannot be guaranteed with larger angles.

The temperature sensor adapts itself automatically to the inclination of the workpiece surface.



- A Approaching an oblique workpiece surface
- **B** Probing: Deflection at two points
- 1 Temperature sensor
- 2 Workpiece
- 3 Deflection at the probe
- 4 Deflection of the temperature sensor; maximum ±5°

## Possibilities

A temperature probe offers the following possibilities:

- Temperature compensation.
- Inclusion of the temperature probe in a CNC program.
- Temperature monitoring.
- Temperature check.
- Temperature recording.

For more information, please refer to the table.

Possibility	Comment
Temperature compensation	When using the temperature probe for temperature compensation, the measuring time after positioning the temperature probe is approximately five seconds. During this time, measured values are continuously transferred, evaluated and saved.
Inclusion of the temperature probe in a CNC program.	sition of the temperature sensor must be known beforehand.
	<ul> <li>Determine the position of the temperature probe.</li> </ul>

2-81

Possibility	Comment
Temperature monitoring	It is possible to define <i>limit values</i> for the temperature. Furthermore, it is possible to define when the temperature measurement is to be carried out.
	There are two possibilities if the limit value is exceeded: A warning appears in the record or the CNC program is cancelled.
Temperature check	The ambient air temperature can be measured at any time. The tem- perature is compared with the limit values.
	There are two possibilities if the limit value is exceeded: A warning appears in the record or the CNC program is cancelled.
Temperature recording	If the data from the last temperature measurement is required, the tem- peratures of the workpiece and the air can be recorded.

#### NOTICE

The measuring software is required in order to use the possibilities offered by the temperature probe. See operating instructions for the measuring software.

# Particularities of probing systems with RDS

If using CALYPSO and/or CMM-OS, the information on RDS is provided in the operating manuals for CALYPSO and CMM-OS.

If you use UMESS, you will receive a separate brochure with information on RDS probing systems.

# **Special features of the RST-P probe**

## **Critical probings with RST-P**

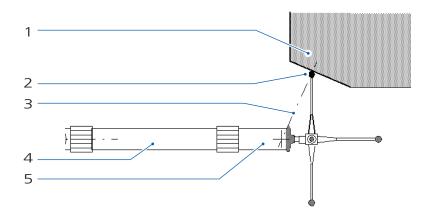
## **Condition for probing pulse**

#### NOTICE

A measured value is only valid if the probing pulse is confirmed by the mechanical contact in the probe within a certain period.

## **Unfavorable conditions**

In certain cases it may happen that the mechanical contact is released too late. In this case, the measured value is not accepted.



- 1 Workpiece
- 2 Probing point with lateral stylus
- 3 Surface normal in the probing point
- 4 Extension of RST-P: > 200 mm
- 5 Probe

Probing may be critical if the following four criteria are fulfilled.

- Use of an extension which is longer than 200 mm for the RST-P probe,
- surface normal at the probing point points to the center of the bearing plane, in the range of  $\pm$  5°,
- probing with lateral stylus,
- the probing direction runs parallel to an axis of the stylus system.

#### NOTICE

Critical probing can be avoided if you ensure that at least one of the above mentioned boundary conditions does not apply during probing.

#### How to avoid critical probings

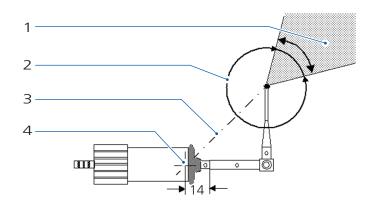
Critical probing can be avoided if the central stylus instead of the lateral stylus is used for the measuring point on the oblique surface.

## Inadmissible zone for reverse probings

The stylus vector is different for each stylus. It determines the admissible and inadmissible zone for the probing.

#### NOTICE

The stylus vector is a connecting line between the stylus tip and the bearing plane of the RST-P probe.



- 1 Inadmissible zone for reverse probings; 60° angle
- 2 Admissible zone for all probing directions
- 3 Stylus vector
- 4 Center of the bearing plane for the RST-P probe.



## **A** CAUTION

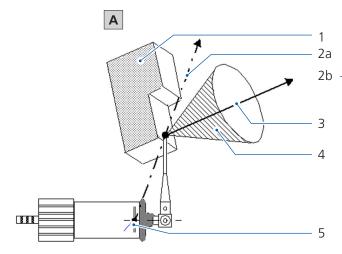
The bearing plane for the RST-P probe must not be loaded in the direction of pull. This may happen during reverse probings if the surface normal of the workpiece to be probed is superimposed on the stylus vector. This may lead to measuring errors and cause damage to the RST-P probe.

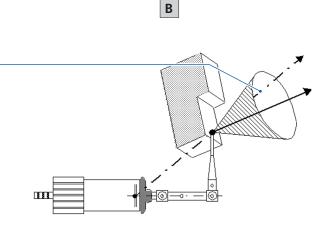
• Do not carry out any reverse probings, if it is possible that a deflection of the stylus within the inadmissible 60° range occurs See examples.

#### NOTICE

Avoid reverse probings. However, if reverse probing is necessary, the stylus with which the largest angle between the surface normal and the stylus vector can be achieved should be used. See diagram above.

## Examples





Examples of admissible and inadmissible reverse probing



- A Admissible reverse probing; the stylus vector lies *outside* the inadmissible range.
- **B** Inadmissible reverse probing; the stylus vector lies *within* the inadmissible vector range.
- 1 Workpiece
- 2a Stylus vector outside the inadmissible range
- 2b Stylus vector within the inadmissible range
- 3 Surface normal of the workpiece in the probing point
- 4 Inadmissible range: 60° cone around the surface normal
- 5 Center of the bearing plane for the RST-P probe.

# Special features of the RDS/XXT probing system

## Dead weight offset

Since the VAST XXT is not equipped with the counterbalancing function of the stylus weight, the stylus sags down, more or less, depending on the weight and orientation of the stylus. The resulting display on the probe-internal path measurement system is called dead weight offset (DWO). Any probing during measuring operation takes place relative to this DWO.

A DWO is determined after certain actions. These actions may *not* be carried out while probing.

These actions include:

- Cold start of the control unit:
- Switching the control unit on and off.
- Rotation of the stylus.
- Stylus system change

#### NOTICE

Make sure that the stylus does not come into contact with anything during these actions. Move the stylus free prior to carrying out one of these actions.

## Notes on the operation

#### Probe deflection and measuring force

The size of the measuring force depends on the probe type (TL1 or TL2) of the stylus length and on the probe deflection on the stylus tip.



#### NOTICE

Very thin styli may break. Styli of the applicable stylus system kit are suitable.

**»Standard« presetting** The recommended presetting for the deflection is »Standard«, selectable in the CALYPSO measuring software. With this setting, the probe deflection during measurement value recording is 0.15 mm. This value is independent of the stylus length.

#### Modes for critical application cases:

Sensitive:	Small deflection, for example for soft workpieces or low scanning speed.
Robust:	High deflection, for example for rough workpieces or high scanning speed.

The different modes can be selected in CALYPSO.

## Qualification

#### NOTICE

The shaft of the reference sphere may not be probed during the qualification.

Please note:

 The maximum deflection occurring during qualification is 0.4 mm. A maximum probing force results from the deflection of 0.4 mm. The resulting probing force depends on the stylus length.

Only styli may be used that will not cause any inadmissible deformations at the maximum probing force.

RDS CAA is not available.

Each RDS position must be qualified separately.

 For requalification of already qualified styli, six probing points are sufficient.

## Probing

 In the case of styli with a very thin stylus shaft, the probing dynamics may have to be reduced.

Dynamic reduction is not necessary for the smallest stylus currently available. The smallest stylus from the stylus system kit for VAST XXT has the following features: 1 mm shaft diameter, 1.5 mm diameter of the stylus tip.

– Self-centering probing is not permitted.

The moments generated by frictional forces lead to inaccurate measurements.

– Disk styli may not be used since those cannot be qualified.

# Special features of the RDS/SP25M probing system

## **Dead weight offset**

Since the SP25M is not equipped with the counterbalancing function of the stylus weight, the stylus sags down, more or less, depending on the weight and orientation of the probe. The resulting display on the probeinternal path measurement system is called dead weight offset (DWO). Any probing during measuring operation takes place relative to this DWO.

A DWO is determined after certain actions. These actions may *not* be carried out while probing.

These actions include:

– Cold start of the control unit:

Switching the control unit on and off.

- Rotation of the stylus.
- Stylus system change

#### NOTICE

Make sure that the stylus does not come into contact with anything during these actions. Move the stylus free prior to carrying out one of these actions.

## Notes on the operation

## Probe deflection and measuring force

The size of the measuring force depends on the scanning module (SM25-2 or SM25-3), the stylus length and on the deflection on the stylus tip.

## NOTICE

Very thin styli may break. Styli of the applicable stylus system kit are suitable.

**»Standard« presetting** The recommended presetting for the deflection is »Standard«, selectable in the CALYPSO measuring software. With this setting, the probe deflection during measurement value recording is 0.15 mm. This value is independent of the stylus length.

## Modes for critical application cases:

Sensitive:	Small deflection, for example for soft workpieces or low scanning speed.
Robust:	High deflection, for example for rough workpieces or high scanning speed.



The different modes can be selected in CALYPSO.

The real measuring force can be estimated from the information given in the SP25M operating instructions.

## Qualification

#### NOTICE

The shaft of the reference sphere may not be probed during the qualification.

Position the reference standard in a way to prevent probing of the shaft.

Please note:

 The maximum deflection occurring during qualification is 0.4 mm. A maximum probing force results from the deflection of 0.4 mm. The resulting probing force depends on the stylus length.

Only styli may be used that will not cause any inadmissible deformations at the maximum probing force.

RDS CAA is not available.

Each RDS position must be qualified separately.

 For requalification of already qualified styli, six probing points are sufficient.

## Probing

 In the case of styli with a very thin stylus shaft, the probing dynamics may have to be reduced.

Dynamic reduction is not necessary for the smallest Renishaw stylus currently available. The geometry of the smallest stylus is currently: 0.7 mm shaft diameter, 0.5 mm diameter of the stylus tip.

- Self-centering probing is not permitted.
  - The moments generated by frictional forces lead to inaccurate measurements.
- Disk styli may not be used since those cannot be qualified.

# Special features of the RDS/SP600 probing system

## Dead weight offset

Since the SP600 is not equipped with the counterbalancing function of the stylus weight, the stylus sags down, more or less, depending on the weight and orientation of the probe. The resulting display on the probeinternal path measurement system is called dead weight offset (DWO). Any probing during measuring operation takes place relative to this DWO. A DWO is determined after certain actions. These actions may *not* be carried out while probing.

These actions include:

- Cold start of the control unit:
  - Switching the control unit on and off.
- Rotation of the stylus.
- Stylus system change

#### NOTICE

Make sure that the stylus does not come into contact with anything during these actions. Move the stylus free prior to carrying out one of these actions.

## Notes on the operation

## Probe deflection and measuring force

An important criterion is the deflection on the stylus tip. The measuring force is proportional to the deflection. A deflection of 0.15 mm corresponds to a measuring force of approx. 150 mN.

**Default setting** The recommended measuring force is 150 mN. This corresponds to the presetting in the measuring software.

## Qualification

- No styli may be used that cannot withstand a measuring force of 500 mN. 500 mN is the highest force encountered during qualification.
- RDS CAA is not available.

Each RDS position must be qualified separately.

 For requalification of already qualified styli, six probing points are sufficient.

## Probing

- In the case of styli with a very thin stylus shaft, the probing dynamics may have to be reduced.
- Self-centering probing is not permitted.

The moments generated by frictional forces lead to inaccurate measurements.

– Disk styli may not be used since those cannot be qualified.



#### Storage in the changer rack

#### NOTICE

A stylus system, that was placed manually in the changer rack, cannot be inserted automatically. Use the automatic run to store a stylus system in the changer rack.

## **Special features of the RDS/ViScan**

The ViScan probe is described in the separate brochure »Optical measurement« providing complete information on the use of the probe.

## **Special features of the DTS**

## Notes on DTS

**LED on the probe** The LEDs on the probe serve to acknowledge a probing. They light up as soon as the probing is successfully completed.

## Unfavorable measuring conditions

Light quantity too low

The light quantity reflected on extremely dark, specular and strongly inclined surfaces is low.

Consequence: No switch signal. Risk of collision!

Example: Black photosensitive resist, concentrating reflectors.

Multiple reflection

On inclined shiny surfaces, the light can be reflected at several points.

*Consequence*: Wrong receiver signal.

Example: Thread.

- Light penetrates into the material.

Certain materials do not disperse the light on the object surface but let the light partly penetrate into the material and disperse it under the surface.

Consequence: Reduced precision.

Examples: Teeth, opal plastic materials, ceramic material.

#### Remedy:

It is possible to remedy the above mentioned problems by coating the problematic surfaces with a diffusely reflecting bright material, e.g. a »Coating Spray Gray« by Wolf&Beck.



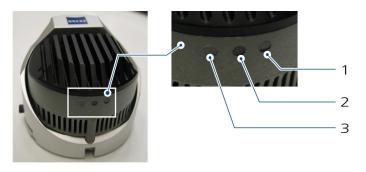
## Risk of collision.

A collision may be caused if no switch signal is generated due to reflection.

# Faults during the measuring run

Error	Cause	Remedy
The power LED on the RDS adapter plate does not light up.	The contacts of the adapter plate are defective or soiled.	<ul> <li>Check and, if necessary, clean the contacts.</li> </ul>
The system clock pulse LED on the RDS adapter plate does not flash.	CAN bus error	<ul> <li>Check and, if necessary, clean the contacts on the RDS adapt- er plate.</li> </ul>
Error message:	Stylus contacts are not closed.	– Remove the adapter plate and
The adapter plate does not fit correctly in the adapter plate receptacle.		insert it again.
	Contacts on the adapter plate or on the adapter plate receptacle are soiled.	– Clean the contacts:
		with a dry or damp cloth.
		<ul><li>Use a mild cleaning agent.</li><li>Dry the contacts to prevent oxidation.</li></ul>
		Make sure that the contacts are free from cleaning agent residues.
Error message during qualif cation: "No result"	The shaft of the reference standard has been probed unintentionally during the automatic qualification.	<ul> <li>Change the position of the reference standard so that the shaft will not be touched during qualification.</li> </ul>
	Stylus or reference standard is loose.	<ul> <li>Fasten the stylus and reference standard firmly.</li> </ul>
	Stylus tip or reference sphere is ex- tremely soiled.	<ul> <li>Clean the stylus tip and reference sphere.</li> </ul>
Measured value not accept-	Contacts are soiled.	- Clean the contacts.
ed during probing.	Contacts are on the adapter plate and its receptacle.	Further information see above.

## LED on the RDS adapter plate



- 1 LED for probe; permanently lit if probe in RDS adapter plate
- 2 System clock pulse LED
- 3 Power LED; permanently lit



### **Technical data**

#### **Probes**

#### ST probe

6; ± X, ± Y, ± Z
< 0.01 N
Vertical: Up to 5 N
Horizontal: Up to 1.4 N
44 mm
200 g / incl. adapter plate
200 mm / stylus + extension
+ 5 ℃ to + 40 ℃
75 dBA with sinusoidal ex- citation
80 dBA noise

#### ST3 probe

Probing directions	6; ± X, ± Y, ± Z
Probing force	
For data transfer	< 0.1 N
For stylus deflection	Vertical: Up to 5 N
	Horizontal: Up to 1.4 N
Diameter of adapter plate	44 mm
Stylus system weight, max.	200 g / incl. adapter plate
Stylus system length, max.	200 mm / stylus + extension

#### **Environmental conditions:**

Ambient temperature for operational readiness	+ 5 °C to + 40 °C
Admissible acoustic pressure	75 dBA with sinusoidal ex- citation
	80 dBA noise

#### DT DynaTouch probe and VAST XT

Dimensions	
Length	91 mm
Width	91 mm
Height	100 mm
Probing directions	6; ± X, ± Y, ± Z
Measuring force	0.05 to 1 N / continuous
Diameter of adapter plate	69 mm
Probe deflection	max. ± 2 mm
Stylus system weight, max.	500 g / incl. adapter plate
Stylus system length, max.	500 mm / stylus + extension
Max. torque of the adapter plate	0.3 Nm
Min. diameter of the stylus tip	0.3 mm (on some CMMs 0.5 mm)
Environmental conditions:	
Ambient temperature for operational readiness	+ 5 ℃ to + 40 ℃
Admissible acoustic pressure	100 dBA with sinusoidal ex- citation
	100 dBA noise

#### **VAST XTR probe**

Dimensions	
Length	91 mm
Width	91 mm
Height	100 mm
Probing directions	6; ± X, ± Y, ± Z



Measuring force	0.05 to 1 N / continuous
Diameter of adapter plate	69 mm
Probe deflection	max. ± 2 mm
Stylus system weight, max.	500 g / incl. adapter plate
Stylus system length, max.	350 mm / stylus + extension
Max. torque of the adapter plate	0.15 Nm
Min. diameter of the stylus tip	0.3 mm (on some CMMs 0.5 mm)
Environmental conditions:	
Ambient temperature for operational readiness	+ 5 ℃ to + 40 ℃
Admissible acoustic pressure	100 dBA with sinusoidal ex- citation
	100 dBA noise

#### VAST gold probe

Dimensions	
Length	91 mm
Width	91 mm
Height	200 mm
Probing directions	6; ± X, ± Y, ± Z
Measuring force	0.05 to 1 N / continuous
Diameter of adapter plate	69 mm
Probe deflection	max. ± 5 mm
Stylus system weight, max.	800 g / incl. adapter plate
Stylus system length,max.	800 mm / stylus + extension
Max. torque of the adapter plate	0.1 Nm
Min. diameter of the stylus tip	0.3 mm
Environmental conditions:	
Ambient temperature for operational readiness	+ 5 °C to + 40 °C
Admissible acoustic pressure	100 dBA with sinusoidal ex- citation
	100 dBA noise

#### **HSS probe**

Probing directions	6; ± X, ± Y, ± Z
Measuring force	0.05 to 1 N / continuous
Diameter of adapter plate	69 mm
Probe deflection	max. ± 2.6 mm
Stylus system weight, max.	600 g / incl. adapter plate
Stylus system length,max.	600 mm / stylus + extension
Max. torque of the adapter plate	0.2 Nm
Min. diameter of the stylus tip	0.3 mm

#### **Environmental conditions:**

Ambient temperature for operational  $+ 15 \degree C$  to  $+ 30 \degree C$ readiness

#### **RDS probing system**

#### RDS

Dimensions	
Diameter	64 mm
Height	140 mm (without adapter)
Adjustment range	
Rotary axis (A)	± 180 °
Tilting axis (B)	± 155 °
	Valid for most of the bridge CMMs. A different angle range may apply in special cases.
Step width	2.5 °
Torque, max.	0.5 Nm

#### **Environmental conditions:**

Ambient temperature for opera-	+ 5 °C to + 40 °C
tional readiness	

#### **RST-P** probe

Diameter	24 mm
Length	56 mm
Weight	44 g
Extensions, max.	300 mm
Probing direction	Direction-independent
Min. diameter of the stylus tip	0.5 mm
Stylus system weight, max.	10 g
Stylus system length, max.	90 mm
Connecting thread	M3

# Ambient temperature for operational<br/>readiness+ 5 °C to + 40 °CAdmissible acoustic pressure75 dBA with sinusoidal ex-<br/>citation<br/>80 dBA noise

#### XDT probe

Probe extension, max.	100 mm
Probing direction	Direction-independent
Min. diameter of the stylus tip	0.3 mm
Stylus system weight, max.	15 g (TL3)
Stylus system length, max.	30 - 150 mm, depending on the version

#### VAST XXT probe

Probe extension, max.	100 mm
Probing direction	Direction-independent
Min. diameter of the stylus tip	0.3 mm
Stylus system weight, max.	10 g (TL1, TL2)
	15 g (TL3)
Stylus system length, max.	30 - 250 mm, depending on the version

#### SP25 probe

Extensions, max.	100 mm
Probing direction	Direction-independent
Min. diameter of the stylus tip	0.5 mm
Stylus system length, max.	50 - 200 mm
	Depending on the scanning module.

#### **Renishaw probes**

Туре		TP6	<b>TP2-5</b>	<b>TP20</b>	<b>TP200</b>
Dimensions					
Diameter	[mm]	25	13	13.2	13.5
Length	[mm]	41	38	38 <sup>1</sup>	30
Weight	[g]	56	22	22	22
Extensions, max.	[mm]	200	300	300	300
Probing direction		±Χ, ±Υ,	±Ζ		
Connecting thread for stylus		M3	M2	M2	M2
<sup>1</sup> including module for probing force. There are several modules for different probing forces.			5		
Environmental con	ditions				
Ambient temperatu readiness	re for op	perationa	l + 5 °	C to + 40 °	С
Admissible acoustic pressure			75 d citati		nusoidal ex-

80 dBA noise

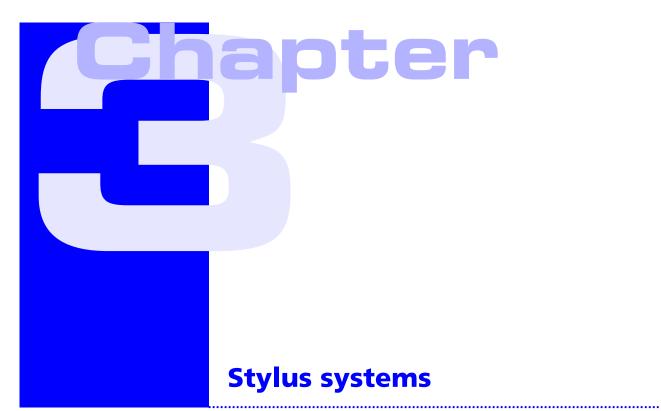
#### **Renishaw probe carrier**

Туре	MIH	<b>MH8</b>	MIP
Adjustment range			
Rotary axis (A)	± 180°	± 180°	± 180°
Tilting axis (B)	± 105°	± 90°	± 105°
Step width	7.5°	15°	15°



Туре	MIH	MH8	MIP
Weight	580 g	205 g	200 g
Extensions, max.	300 mm	50 mm	300 mm
Туре	PH10	PH1	PH6
Adjustment range			
Rotary axis (A)	± 180°	± 180°	-
Tilting axis (B)	± 105°	± 105	-
Step width			
Rotary axis (A)	7.5°	15°	-
Tilting axis (B)	7.5°	Variable	-
Weight	645 g	125 g	48 g
Extensions, max.	300 mm	-	-





What is a stylus tip and what has to be observed when assembling a stylus system?

#### This chapter contains:

Information on the stylus system	3 <b>-</b> 2
Stylus system assembly	3-8
Inserting / removing the stylus system	3-16
Start-up checklist	3-19



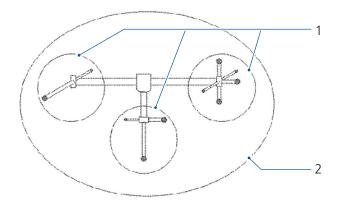
#### Information on the stylus system

#### **Probing system components**

A stylus consists of one or more styli and joining elements.

Stylus combination

A distinction is made between stylus system and stylus combination. The stylus system can consist of several stylus combinations. A stylus combination consists of several styli.



- 1 Stylus combinations
- 2 Stylus system

#### NOTICE

It is basically possible to create a stylus system with several stylus combinations. However, certain assembly criteria must be observed to ensure exact measurement.  $\succ$  See [ $\Rightarrow$  3-9]

#### **Design and functions**

#### Stylus

Shaft + stylus tip

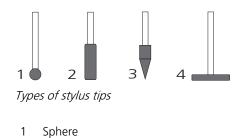
A stylus consists of a shaft and a stylus tip. Shafts differ with regard to size and material. Furthermore, stylus tips differ with regard to form. See [ $\Rightarrow$  3-2]

#### **Connecting elements**

The probe kits for the probing systems contain styli of different sizes and components used to create stylus systems, e.g. extensions.

#### **Stylus tips**

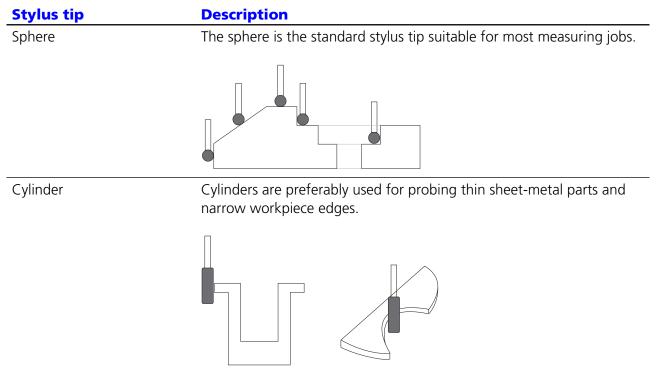
Stylus tips may have various forms. Examples of stylus tips: Sphere, cylinder.



2 Cylinder

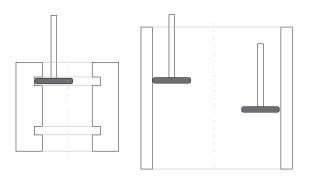
- 3 Cone
- 4 Disk

#### Application of the stylus tips



Stylus tip	Description
Cone	Cones are required for two applications:
	1. Self-centering probing
	2. High-precision probing of specified positions.
Disk	A disk is used for probing deep grooves and large holes. For large he a disk offers the advantage of shorter travel paths as compared with

noles, the sphere.



#### **Principles for assembly**

#### **Principles for assembly**

There are two ways to assemble a stylus system:

- 1. Screwing technique
- 2. The clamping technique.

Preference should be given to the screwing technique.

Stylus systems may be assembled individually. Probe kits with different components are available.

#### NOTICE

The limit values for probing systems must be observed when assembling.

#### Screwing technique

The stylus system components have threads for screwing the components together. Depending on the probing system, different thread sizes are used: M2, M3 and M5.

M5:	ST, ST 3 and VAST gold
M2, M3:	RST-P, VAST XXT and Renishaw probes.

#### Technical data of stylus system components

The stylus system components differ with regard to material and geometry, e.g. length of the stylus and diameter of the stylus tip.

The following table shows the technical data of some available styli. This data reveals the influence of the material and the geometric sizes (e.g. length of the stylus) upon the weight of the stylus. A table with the technical data of other stylus system components is included with the stylus system kits.

#### d Weight L D ML ds [mm] [g] Hard metal -M5 П 15 2 3 25 11 4 0 3 2 4 33.5 11 23.5 5 ML 50 40 3.5 9 L 11 8 25 63.5 11 50.5 6 8 114.5 19 92.5 6 59 9 64.5 19 42.5 6 38 10 65.5 11 52.5 27 6 Ceramic material<sup>1</sup> 5 53 11 43 3.5 5 8 8 63.5 11 50.5 6 8 114.5 19 101.5 6 38 9 64.5 19 42.5 6 34 10 65.5 11 52.5 6 9 <sup>1</sup> The stylus shaft is made of ceramic material.

#### Excerpt from technical data of styli:

#### Stylus system kits

There are different stylus system kits for probing systems, such as for small and for large workpieces.

#### **Clamping technique**

Laterally oriented styli are inserted in grooved discs and clamped by the vertically oriented end stylus. The end stylus is screwed into the stylus extension or directly into the adapter plate. In this way the laterally oriented styli are clamped.

The stylus system components for the clamping technique and assembly instructions are included in the stylus system kit.

#### ThermoFit

CFRP styli and CFRP extensions are used for special measuring jobs. *Advantages*.

#### Advantages:

- No length modifications caused by varying temperatures
- Low weight.

#### Storage of stylus systems

Once the stylus has been assembled, it can be used as long as required. It does not need to be disassembled. Careful handling is necessary. This applies particularly to the adapter plate and stylus tips.

#### **Stylus system protection**

The stylus system must be protected against the following influences:

- Force of impact and other external mechanical influences.
- Dust and dirt.

A changer rack is recommended for storage if you measure every day with the CMM. When no measurements are carried out with the CMM over a longer period, the stylus systems should be stored in a place protected against environmental influences:

#### Storage options:

Separate pack- ing materials	E.g. box made of cardboard, styrofoam, wood When using a metal box, wrap the stylus system in a cloth. This is necessary to protect the adapter plate and stylus tips against being scratched.
Drawer	Wrap the stylus system in a cloth or lay it on a soft support. This is necessary to protect the adapter plate and stylus tips against being scratched.
Special cabinet	The stylus systems are inserted in holders. Such a cab- inet is available from Carl Zeiss.



Stylus cabinet



#### **Stylus system assembly**

# Screwing technique or clamping technique?

Although the stylus system can be assembled by clamping its parts together, it is preferable to use the screwing technique.

#### Advantages of the screwing technique:

- Easy assembly
- Complex stylus systems possible
- Stable construction.

The following example describes how to assemble stylus systems using the screwing technique. Further information is given elsewhere. ➤ See [
⇒ 3-4]

# Safety instructions and measures of precaution

#### Safety instructions



#### A DANGER

Stylus tips are generally made of ruby. By a fall on hard ground, the stylus tips can splinter. Thereby, injuries can be caused by splinters.

• Treat styli and other stylus system components carefully. Also, do not drop them.

#### Measures of precaution



Stylus systems must not be assembled on the probe. The probe could thereby be damaged.

• Do not attach any styli to the stylus system as long as the stylus system is located in the adapter plate receptacle.



Assemble the stylus systems carefully. Do not exert any force when screwing the components together. Furthermore, you should wear gloves, thus avoiding an excess heating of the stylus. Due to this heating the measuring results can be falsified.

- Screw the components together manually. Assemble them fully.
- Use the pin included in the kit to tighten the components.

Observe the limit values regarding weight and length when assembling the stylus system. The limit values depend on the probing system. ► See [=> 3-9]



The weight of all components and the length of the stylus, extensions and joining elements must be considered when assembling a stylus system.

- Observe also the *weights indicated* for the individual styli, joining elements and the adapter plate when assembling a stylus system.
- Observe the *length specifications* for the styli, extensions and other joining elements when assembling a stylus system.



The joint of the RST-P on which styli are mounted must not be damaged under any circumstances.

• When mounting styli, use the supplied auxiliary tool to fasten the joint.

#### **Criteria and limit values**

#### Criteria

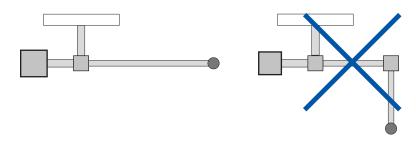
An unfavorable stylus system configuration may impair the measuring accuracy. Therefore, it is necessary to observe the following criteria for assembly.

- Only use styli with an M5 thread.
- Stable structure with as few components as possible.
- Symmetrical structure with respect to weight; the center of gravity must be located in the physical center; use counterweights if necessary.

Stylus extensions may be used as counterweights.

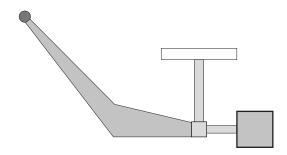
**NOTICE!** Check the balance by holding the adapter plate between two fingers and letting the stylus system swing back and forth until it comes to a stop. The stylus system must point downward in a vertical direction.

– Do not assemble probes with more than *one* branching.



 If possible, never use joints when assembling oblique stylus configurations.

It is preferable to use components shaped according to your corresponding requirements. You can also make such components yourself, provided that you observe the permissible limit values for the stylus system.



- Use only components that are in perfect condition.

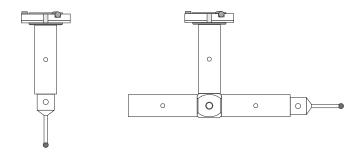
Component requirements:

- Not damaged
- Clean
- Grease-free
- Observe the limit values for the stylus system: Length, weight and torque.

#### Instructions for ST and ST 3

Extensions

Short and long thin styli are not suitable. Preferable, extensions should be used. This applies for vertical as well as horizontally-oriented styli.



#### Advantages:

- Higher stability of the stylus system configuration,
- Reduced deflection force on the stylus tip,
- Improved probing precision.

Contact surfaces plan	If own stylus system components are used, then it must be noted that all contact surfaces are surface-ground. Only then a firm fit of the in- terfaced components is guaranteed.
Unfavorable styli	Long styli, for which the stylus shaft is only kept in a small area, are not suitable. Especially the following styli should not be used:
	✓ Ø 3 mm ✓ 56 mm
	With this stylus, the stylus shaft is only kept in a small area. Alternatively, also styli, whose shaft is kept in a longer area, are suitable.
One-sided clamped styli	Basically, the clamping technique should be avoided when assembling the stylus system. One-sided clamped styli should not be used at all. Example:
	1 Support for styli
	<ol> <li>Locking screws</li> <li>Direction, in which the stylus is not fastened.</li> </ol>
	In this example, the stylus shaft is guided into a support and fastened there with a locking screw. The problem is here, that the stylus shaft is only fastened in one direction.
	<b>NOTICE!</b> If this clamping technique cannot be avoided, then the styli

must be glued in the support.



	CAUTION! If a stylus is located outside the admissible zone, prob- ing errors may be caused. Furthermore, the probe may become damaged, especially during reverse probings.		
	<b>NOTICE!</b> When assembling a stylus system, make sure that the styli are arranged within the admissible zone.		
Limited central zone [B]	If reverse probing is to be carried out, the styli arranged in the conical central zone must not be used for the probing.		
Admissible zone <b>[A]</b>	When probing forwards and sidewards, all stylus systems, in which the styli are arranged within the drawn semicircular area, are admissible.		
	4 Data in mm		
	3 Forward		
	2 Reverse		
	1 Lateral		
	<b>B</b> Limited central zone for reverse probings		
	A Admissible zone for the stylus		
	B		
	A		

#### Admissible zone for the RST-P

#### **Limit values**

To ensure error-free measurement by the probing system, the maximum weight and length must not be exceeded. Furthermore, the maximum torque may not be exceeded.

#### **Overview**

The limit values depend on the probing system used. The limit values of the available probing systems are listed below:

#### NOTICE

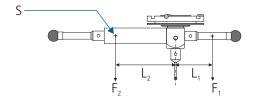
The limit values for the maximum weight refer to stylus system and adapter plate. For some probes, there is no adapter plate, for example RST-P.

Probing system	Length	Weight	Torque
ST	200	200	-
ST 3	200	200	_
ST-ATAC	200	200	-
XDT-TL3 and RDS with XDT- TL3	150	15	_
VAST XXT-TLx and RDS with VAST XXT-TLx			
-TL1	125	10	-
-TL2	250	10	-
-TL3	150	15	-
DT DynaTouch	500	500	0.3
VAST XT and VAST XT gold	500	500	0.3
VAST XTR	350	500	0.15
VAST and VAST gold	800	800	0.1
HSS	600	600	0.2
RDS with RST or RST-P	90	10	_
RDS with XDT	See XDT		
RDS with VAST XXT	See VAST XXT		
RDS with TP6	See Renishaw operatir	ng instructions.	
RDS with TP2	See Renishaw operatir	ng instructions.	
RDS with TP20	See Renishaw operating instructions.		
RDS with TP200	See Renishaw operating instructions.		
RDS with SP25 or SP25M	See Renishaw operating instructions.		
RDS with SP600	200	20	-
RDS with ViScan	_	-	-
RDS with LineScan	_	_	-
RDS with DTS	_	_	_

#### **Calculation of the torque**

The  $K_{M}$  torque can be calculated as follows:

$$K_{M} = |F_2 \times L_2 - F_1 \times L_1|$$



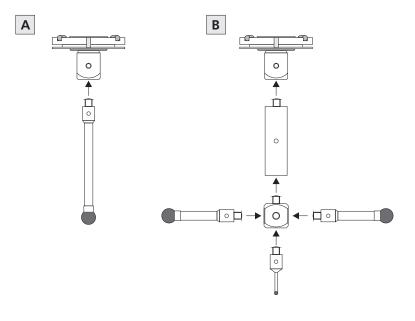
- S: Center of gravity of a probe
- F: Force in the center of gravity
- L: Distance between the center of gravity and the bisecting line

#### Example

Connecting parts are normally needed to assemble the required stylus systems. It is also possible to screw the stylus directly into the adapter plate.

Screwing technique

Assembly example, applying the screwing technique with the VAST adapter plate:



- A Stylus in the adapter plate
- B Extension in adapter plate

#### Aligning the stylus system

It is still possible to align the stylus system after it has been assembled. This may be necessary if some points on the workpiece cannot be probed.



Stylus systems for the RDS probing probing system must not be aligned.

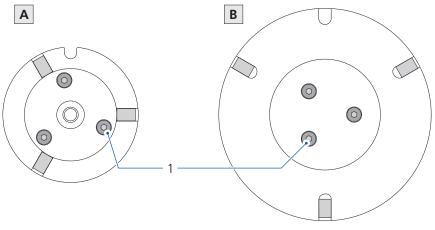


#### NOTICE

During the alignment, make sure that shaft probing is prevented during probing.

#### **Procedure:**

1 Loosen the three screws in the adapter plate so that the stylus system can be turned. **NOTICE! Do not completely unscrew the screws.** 



Adapter plate

- A Adapter plate for ST 3; the adapter plate for ST has spheres instead of cylinders
- **B** Adapter plate for VAST gold and HSS
- 1 Screws
- 2 Insert the stylus system in the adapter plate receptacle.
- **3** Turn the stylus system until the required position is reached.
- **4** Hold the stylus system tight and remove it from the adapter plate receptacle.
- 5 Tighten the screws until you feel a resistance.Torque for tightening the screws:

Adapter plate for ST and ST 3:	1 Nm
Adapter plate for VAST gold and HSS:	2 Nm



#### Inserting / removing the stylus system

#### **Measures of precaution**

The stylus system is held in place by an electromagnet or solenoid. If the measuring software calls for an insertion or change of the stylus system, the magnetic force is reduced. After insertion of the stylus system, the full magnetic force becomes effective after a short delay.

The measuring software is required for inserting and changing a stylus system. See operating instructions for the measuring software.



#### Damage to the probe.

Stylus systems must not be assembled on the probe. The probe could thereby be damaged.

- Insert only finished stylus systems, equipped with all necessary styli.
- Do not attach any styli to the stylus system as long as the stylus system is located in the adapter plate receptacle.



A VAST and HSS probing system automatically falls off of the adapter plate receptacle after a specified period of time following the initiation of the stylus system change.

 Hold onto the stylus system immediately after activating the change in order to avoid damaging the stylus system, the workpiece or the measuring table.

The period of time after which the stylus system falls off is set in the measuring software.

#### Inserting the stylus system

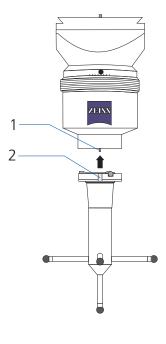
The procedure for inserting a stylus system is basically the same as for the individual probing systems. This procedure must be initiated by the measuring software. See operating instructions for the measuring software.

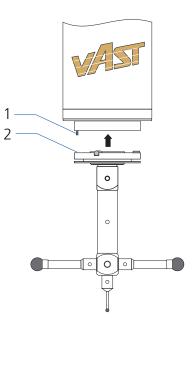
**1** Initiate the procedure via the measuring software.

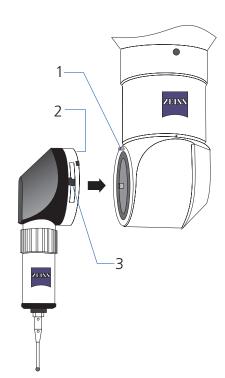
Then insert the stylus system within 20 seconds. If the stylus system is not inserted within this time, you have to repeat this procedure.

**2** Insert the stylus system in the adapter plate receptacle.

The pin must engage inside the groove. See diagram. The stylus system is attracted by the magnet. As soon as the insertion of the stylus system is complete, this is signaled by an audible click.







- 1 Pin in the adapter plate receptacle of the probe
- 2 Groove in the adapter plate
- 3 Push-button for releasing the safety catch; press the push-button only when removing the RDS adapter plate.

#### Position of the pin:

ST and ST 3	Pin at the front.
VAST gold	Pin on the left side.
RDS with RST-P	Pin at any location; the location depends on the tilting axis adjustment. The angle of the tilting axis is set in the measuring software.

#### NOTICE

With ST and ST 3 probing systems, counterbalancing is required after insertion of the the stylus system.  $\succ$  See [ $\Rightarrow$  2-7] and  $\succ$  see [ $\Rightarrow$  2-11]

#### **Removing the stylus system (manually)**

The procedure for removing a stylus system is basically the same as for the individual probing systems. However, several special points must be observed. This procedure must be initiated by the measuring software. See operating instructions for the measuring software.

1 Initiate the procedure via the measuring software.

With regard to the VAST and HSS probing system, the delay required until the stylus system is released from the adapter plate receptacle must be specified in the measuring software. Set the delay so that enough time always remains to grasp the stylus system after initiating the stylus system removal. This is essential to prevent damage to stylus systems, workpieces or the measuring table caused by falling.

2 Remove the stylus system.

#### Special features regarding probing systems:

ST and ST 3	The stylus system must be deflected manually. Then the adapter plate is released from the adapter plate receptacle.	
DT DynaTouch, VAST XT gold, VAST gold	Hold the stylus system; it falls off automatically.	
VAST XTR	You must press two unlock buttons on the adapter plate at the same time and keep them pressed.	
RDS with RST-P	The stylus system must be deflected manually. Then the magnet is re- leased from the RDS adapter plate receptacle.	
RDS with Renishaw TP probes	The stylus system must be deflected manually. Then the magnet is re- leased from the RDS adapter plate receptacle.	
RDS, XDT and VAST XXT	- The stylus system is held magnetically and can be removed manually.	
	<ul> <li>Hold the stylus system below the adapter plate and tilt it to the side.</li> </ul>	
RDS with SP25 or SP25M	- The stylus system is held magnetically and can be removed manually.	
	<ul> <li>The scanning module is held magnetically and can be removed man- ually.</li> </ul>	
RDS with SP600	The stylus system is held magnetically and can be removed manually.	

#### NOTICE

The RDS adapter plate is locked. To remove it, the button on the RDS adapter plate must be pressed.

#### Start-up checklist

#### Stylus system assembly

- Have the criteria for the assembly been observed? ➤ See [=> 3-9].
- Have the limit values for the stylus system been observed?
   See [⇒ 3-12].

#### Inserting the stylus system

 Has the stylus system counterbalancing been performed? - Required only for ST and ST 3.





# 

For the automatic change of stylus systems or probing systems, changer racks are required. Following, you receive an overview on the different changer racks.

.....

#### This chapter contains:

Information for the changer rack	4-2
MSR changer rack	4-3
Renishaw changer rack	4-7



#### **Information for the changer rack**

#### NOTICE

The changer rack must be mounted and installed such that there is a distance of at least 25 mm between the changer rack and the column of the bridge.

#### NOTICE

Exact changer rack alignment is necessary to enable trouble-free stylus system change. The deviation must not exceed 0.1 mm over the total length of the profile rail.

When fastening the holders, it is important to make sure that the holders are pressed downwards against the profile rail during fastening.

#### NOTICE

The qualification of the stylus system holder is a necessary condition for an automatic change of the stylus system. For more information, please refer to the operating instructions for the measuring software.

The qualification of the VAST XTR stylus system holder is described in this document.  $\succ$  See [ $\Rightarrow$  2-69]

#### **MSR changer rack**

#### **MSR changer rack**

The changer rack is preassembled. According to specification, it has two levels, a third level is optional. The height depends on the CMM.



The holders for the adapter plates of various probing systems, such as VAST and RDS, can be mounted on the profile rails.

For more information, please refer to the operating instructions for the CMM.

#### **MSR** mini

A space-saving changer rack is available for a CMM with small measuring range.



#### **Holders**

In the following, the holders for different probing systems are shown. All holders can be mounted on a changer rack.



Probing system	Holder	Comment
ST and ST 3		
VAST, VAST XT, DT Dyna- Touch, HSS	<image/>	<b>NOTICE!</b> The VAST holder may not be used for the VAST XTR.
VAST, VAST XT, DT Dyna- Touch,VAST XTR	The second	

Probing system	Holder	Comment
RDS		
VAST XXT, XDT		This is a unit with three hold- ers. The storage unit is mounted on the profile rail of a changer rack.
	TCR 28.1 114	The separate holder is mounted to the profile rail of a changer rack.

ZCR-28-1-1W



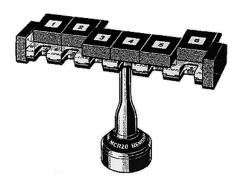
Probing system	Holder	Comment
SP600		The holder is mounted on the profile rail of a changer rack.
FCR25 changer rack for SP25M		The FCR25 changer rack is used for storing SM25 scan- ning modules and SH25 adapter plates. An adapter is needed for the adapter plates.
		The FCR25 changer rack is mounted on the profile rail of a changer rack.

#### See also

• ➤ Use of other adapter plates [=> 2-74]

#### **Renishaw changer rack**

MCR20 changer rack



The MCR20 changer rack is used for storing TP20 probe modules.

SCR200 changer rack



The SCR200 changer rack is used for storing TP200 probe modules.



# Glossary

Term	Explanation
ATAC	Acronym for »Adaptive Touch Advanced Control«; probing strategy for the ST 3 probe
CAN bus	Asynchronous, serial bus system (CAN: acronym for »Local Area Network«)
CFRP	Abbreviation for »Carbon Fiber Reinforced Plastic«.
СММ	Abbreviation for »coordinate measuring machine«
LED	Acronym for »light-emitting diode«
MSR	Acronym for »Multi Sensor Rack«





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